



Designation: **D 6216 – 9803**

Standard Practice for Opacity Monitor Manufacturers to Certify Conformance with Design and Performance Specifications¹

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1. Scope*

1.1 This practice covers the procedure for certifying continuous opacity monitors. It includes design and performance specifications, test procedures, and quality assurance requirements to ensure that continuous opacity monitors meet minimum design and calibration requirements, necessary in part, for accurate opacity monitoring measurements in regulatory environmental opacity monitoring applications subject to 10 % or higher opacity standards.

1.2 This practice applies specifically to the original manufacturer, or to those involved in the repair, remanufacture, or resale of opacity monitors.

1.3 Test procedures that specifically apply to the various equipment configurations of component equipment that comprise either a transmissometer, an opacity monitor, or complete opacity monitoring system are detailed in this practice.

1.4 The specifications and test procedures contained in this practice ~~exceed that of~~ have been adopted by reference by the United States Environmental Protection Agency (USEPA). For each opacity monitor or monitoring system that the manufacturer demonstrates conformance to this practice, the manufacturer may issue a certificate that states ~~that~~ that opacity monitor or monitoring system conforms with all of the applicable design and performance requirements of 40 CFR 60, Appendix B, Performance Specification 1 except those for which tests are required after installation.

¹ This practice is under the jurisdiction of ASTM Committee D-22 on Sampling and Analysis of Atmospheres and is the direct responsibility of Subcommittee D22.03 on Ambient Atmospheres and Source Emissions.

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*A Summary of Changes section appears at the end of this standard.

2. Referenced Documents

2.1 ASTM Standards:²

D 1356 Terminology Relating to Sampling and Analysis of Atmospheres

2.2 U.S. Environmental Protection Agency Document:³

40 CFR 60 Appendix B, Performance Specification 1

2.3 Other Documents:

ISO/DIS 9004 Quality Management and Quality System Elements-Guidelines⁴

ANSI/NCSL Z 540-1-1994 Calibration Laboratories and Measuring Equipment - General Requirements⁴

NIST 260-116 - Filter calibration procedures⁵

3. Terminology

3.1 For terminology relevant to this practice, see Terminology D 1356.

3.2 Definitions of Terms Specific to This Standard:

Analyzer Equipment

3.2.1 *opacity, n*—measurement of the degree to which particulate emissions reduce (due to absorption, reflection, and scattering) the intensity of transmitted photopic light and obscure the view of an object through ambient air, an effluent gas stream, or an optical medium, of a given pathlength.

3.2.1.1 *Discussion*—Opacity (Op), expressed as a percent, is related to transmitted light, (T) through the equation:

$$Op = (1 - T) (100). \quad (1)$$

3.2.2 *opacity monitor, n*—an instrument that continuously determines the opacity of emissions released to the atmosphere.

3.2.2.1 *Discussion*—An opacity monitor includes a transmissometer that determines the *in-situ* opacity, a means to correct opacity measurements to equivalent single-pass opacity values that would be observed at the pathlength of the emission outlet, and all other interface and peripheral equipment necessary for continuous operation.

3.2.2.2 *Discussion*—An opacity monitor may include the following: (1) sample interface equipment such as filters and purge air blowers to protect the instrument and minimize contamination of exposed optical surfaces, (2) shutters or other devices to provide protection during power outages or failure of the sample interface, and (3) a remote control unit to facilitate monitoring the output of the instrument, initiation of zero and upscale calibration checks, or control of other-*ea* opacity monitor functions.

3.2.3 *opacity monitor model, n*—a specific transmissometer or opacity monitor configuration identified by the specific measurement system design, including: (1) the use of specific light source, detector(s), lenses, mirrors, and other optical components, (2) the physical arrangement of optical and other principal components, (3) the specific electronics configuration and signal processing approach, (4) the specific calibration check mechanisms and drift/dust compensation devices and approaches, and (5) the specific software version and data processing algorithms, as implemented in a particular manufacturing process, at a particular facility and subject to an identifiable quality assurance system.

3.2.3.1 *Discussion*—Changing the retro-reflector material or the size of the retro-reflector aperture is not considered to be a model change unless it changes the basic attributes of the optical system.

3.2.3.2 *Discussion*—Minor changes to software or data outputs may not be considered as a model change provided that the manufacturer documents all such changes and provides a satisfactory explanation in a report.

3.2.4 *opacity monitoring system, n*—the entire set of equipment necessary to monitor continuously the in-stack opacity, average the emission measurement data, and permanently record monitoring results.

3.2.4.1 *Discussion*—An opacity monitoring system includes at least one opacity monitor with all of its associated interface and peripheral equipment and the specific data recording system (including software) employed by the end user. An opacity monitoring system may include multiple opacity monitors and a common data acquisition and recording system.

3.2.5 *optical density (OD), n*—a logarithmic measure of the amount of incident light attenuated.

3.2.5.1 *Discussion*—OD is related to transmittance and opacity as follows:

$$OD = \log_{10} (1/T) = -\log_{10} (T) = -\log_{10} (1 - Op), \quad (2)$$

where Op is expressed as a fraction.

3.2.6 *transmittance, n*—the fraction of incident light within a specified optical region that passes through an optical medium.

3.2.7 *transmissometer, n*—an instrument that passes light through a particulate-laden effluent stream and measures *in situ* the optical transmittance of that light within a specified wavelength region.

² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards*, Vol 11.03, volume information, refer to the standard's Document Summary page on the ASTM website.

³ Available from Superintendent of Documents, U.S. Government Printing Office Superintendent of Documents, 732 N. Capitol St., NW, Mail Stop: SDE, Washington, DC 204021.

⁴ Available from American National Standards Institute (ANSI), 11 W. 42nd St., 13th floor, 4th Floor, New York, NY 10036.

⁵ Available from National Institute of Standards and Technology (NIST), 100 Bureau Dr., Stop 3460, Gaithersburg, MD 20899-3460.

3.2.7.1 *Discussion*—Single-pass transmissometers consist of a light source and detector components mounted on opposite ends of the measurement path. Double-pass instruments consist of a transceiver (including both light source and detector components) and a reflector mounted on opposite ends of the measurement path.

3.2.7.2 *Discussion*—For the purposes of this practice, the transmissometer includes the following mechanisms (1) means to verify the optical alignment of the components and (2) simulated zero and upscale calibration devices to check calibration drifts when the instrument is installed on a stack or duct.

3.2.7.3 *Discussion*—Transmissometers are sometimes referred to as *opacity analyzers* when they are configured to measure opacity.

Analyzer Zero Adjustments and Devices

3.2.8 *dust compensation, n*—a method or procedure for systematically adjusting the output of a transmissometer to account for reduction in transmitted light reaching the detector (apparent increase in opacity) that is specifically due to the accumulation of dust (that is, particulate matter) on the exposed optical surfaces of the transmissometer.

3.2.8.1 *Discussion*—~~The dust—Dust compensation is determined relative to the previous occasion when the exposed optics were cleaned and the dust compensation was reset to zero. The determination of dust accumulation on surfaces exposed to the effluent must may be limited to only those surfaces through which the light beam passes under normal opacity measurement and the simulated zero device or equivalent mechanism necessary for the dust compensation measurement. included as an optional feature but is not required.~~

3.2.8.2 *Discussion*—~~The dust compensation is determined relative to the previous occasion when the exposed optics were cleaned and the dust compensation was reset to zero. The determination of dust accumulation on surfaces exposed to the effluent must be limited to only those surfaces through which the light beam passes under normal opacity measurement and the simulated zero device or equivalent mechanism necessary for the dust compensation measurement. The determination of dust compensation is not required to include all surfaces exposed to the effluent or dust accumulation.~~

3.2.8.3 *Discussion*—~~The dust accumulation for all of the optical surfaces included in the dust compensation method must actually be measured. Unlike zero drift, which may be either positive or negative, dust compensation can only reduce the apparent opacity. A dust compensation procedure can correct for specific bias and provide measurement results equivalent to the *clean window* condition.~~

3.2.8.34 *Discussion*—~~In those cases where dust compensation is used, the opacity monitor must provide a means to display the level of dust compensation. Regulatory requirements may impose a limit on the amount of dust compensation that can be applied and require that an alarm be activated when the limit is reached.~~

3.2.9 *external zero device, n*—an external device for checking the zero alignment of the transmissometer by simulating the zero opacity condition for a specific installed opacity monitor.

3.2.10 *simulated zero device, n*—an automated mechanism within the transmissometer that produces a simulated clear path condition or low level opacity condition.

3.2.10.1 *Discussion*—The simulated zero device is used to check zero drift daily or more frequently and whenever necessary (for example, after corrective actions or repairs) to assess opacity monitor performance while the instrument is installed on the stack or duct.

3.2.10.2 *Discussion*—The proper response to the simulated zero device is established under clear path conditions while the transmissometer is optically aligned at the installation pathlength and accurately calibrated. The simulated zero device is then the surrogate, clear path calibration value, while the opacity monitor is in service.

3.2.10.3 *Discussion*—Simulated zero checks do not necessarily assess the optical alignment, the reflector status (for double-pass systems), or the dust contamination level on all optical surfaces. (See also 6.9.1.)

3.2.11 *zero alignment, n*—the process of establishing the quantitative relationship between the simulated zero device and the actual clear path opacity responses of a transmissometer.

3.2.12 *zero compensation, n*—an automatic adjustment of the transmissometer to achieve the correct response to the simulated zero device.

3.2.12.1 *Discussion*—The zero compensation adjustment is fundamental to the transmissometer design and may be inherent to its operation (for example, continuous adjustment based on comparison to reference values/conditions, use of automatic control mechanisms, rapid comparisons with simulated zero and upscale calibration drift check values, and so forth) or it may occur each time a calibration check cycle (zero and upscale calibration drift check) is performed by applying either analog or digital adjustments within the transmissometer.

3.2.12.2 *Discussion*—For opacity monitors that do not distinguish between zero compensation and dust compensation, the accumulated zero compensation may be designated as the dust compensation. Regulatory requirements may impose a limit on the amount of dust compensation that can be applied and require that an alarm be activated when the limit is reached.

3.2.13 *zero drift, n*—the difference between the opacity monitor response to the simulated zero device and its nominal value (reported as percent opacity) after a period of normal continuous operation during which no maintenance, repairs, or external adjustments to the opacity monitor took place.

3.2.13.1 *Discussion*—Zero drift may occur due to changes in the light source, changes in the detector, variations due to internal scattering, changes in electronic components, or varying environmental conditions such as temperature, voltage or other external

factors. Depending on the design of the transmissometer, particulate matter (that is, dust) deposited on optical surfaces may contribute to zero drift. Zero drift may be positive or negative.

Calibrations and Adjustments

3.2.14 *attenuator, n*—a glass or grid filter that reduces the transmittance of light.

3.2.15 *calibration drift, n*—the difference between the opacity monitor response to the upscale calibration device and its nominal value after a period of normal continuous operation during which no maintenance, repairs, or external adjustments to the opacity monitor took place.

3.2.15.1 *Discussion*—Calibration drift may be determined after determining and correcting for zero drift. For opacity monitors that include automatic zero compensation or dust compensation features, calibration drift may be determined after zero drift or dust compensation, or both, are applied.

3.2.16 *calibration error, n*—the sum of the absolute value of the mean difference and confidence coefficient for the opacity values indicated by an optically aligned opacity monitor (laboratory test) or opacity monitoring system (field test) as compared to the known values of three calibration attenuators under clear path conditions.

3.2.16.1 *Discussion*—The calibration error indicates the fundamental calibration status of the opacity.

3.2.17 *external adjustment, n*—either (1) a physical adjustment to a component of the opacity monitoring system that affects its response or its performance, or (2) an adjustment applied by the data acquisition system (for example, mathematical adjustment to compensate for drift) which is external to the transmissometer and control unit, if applicable.

3.2.17.1 *Discussion*—External adjustments are made at the election of the end user but may be subject to various regulatory requirements.

3.2.18 *intrinsic adjustment, n*—an automatic and essential feature of an opacity monitor that provides for the internal control of specific components or adjustment of the opacity monitor response in a manner consistent with the manufacturer's design of the instrument and its intended operation.

3.2.18.1 *Discussion*—Examples of intrinsic adjustments include automatic gain control used to maintain signal amplitudes constant with respect to some reference value, or the technique of ratioing the measurement and reference beams in dual beam systems. Intrinsic adjustments are either non-elective or are configured according to factory recommended procedures; they are not subject to change from time to time at the discretion of the end user.

3.2.19 *upscale calibration device, n*—an automated mechanism (employing a filter or reduced reflectance device) within the transmissometer that produces an upscale opacity value.

3.2.19.1 *Discussion*—The upscale calibration device is used to check the upscale drift of the measurement system. It may be used in conjunction with the simulated zero device (for example, filter superimposed on simulated zero reflector) or a parallel fashion (for example, zero and upscale (reduced reflectance) devices applied to the light beam sequentially). (See also 6.9.2.)

Opacity Monitor Location Characteristics

3.2.20 *installation pathlength, n*—the installation flange-to-flange separation distance between the transceiver and reflector for a double-pass transmissometer or between the transmitter and receiver for a single-pass transmissometer.

3.2.21 *monitoring pathlength, n*—the effective single pass depth of effluent between the receiver and the transmitter of a single-pass transmissometer, or between the transceiver and reflector of a double-pass transmissometer at the installation location.

3.2.22 *emission outlet pathlength, n*—the physical pathlength (single pass depth of effluent) at the location where emissions are released to the atmosphere.

3.2.22.1 *Discussion*—For circular stacks, the emission outlet pathlength is the internal diameter at the stack exit. For non-circular outlets, the emission outlet pathlength is the hydraulic diameter. For rectangular stacks:

$$D = (2LW)/(L + W), \quad (3)$$

where L is the length of the outlet and W is the width of the stack exit.

3.2.23 *pathlength correction factor (PLCF), n*—the ratio of the emission outlet pathlength to the monitoring pathlength.

3.2.23.1 *Discussion*—The PLCF is used to calculate the equivalent single pass opacity that would be observed at the stack exit.

3.2.23.2 *Discussion*—A number of similar terms are found in the literature, manufacturer operating manuals, and in common usage. OPLR (optical pathlength ratio) and STR (stack taper ratio) are common. The OPLR is equal to one half of the pathlength correction. Refer to the instrument manufacturer for the proper factor.

3.2.23.3 *Discussion—Warning*—In cases where the PLCF value is greater than typical values, (for example, greater than two) the effects of measurement errors will be significantly increased.

Opacity Monitor Optical Characteristics

3.2.24 *angle of projection (AOP), n*—the total angle that contains all of the visible (photopic) radiation projected from the light source of the transmissometer at a level greater than 2.5 % of its peak illuminance.

3.2.25 *angle of view (AOV), n*—the total angle that contains all of the visible (photopic) radiation detected by the photodetector assembly of the transmissometer at a level greater than 2.5 % of the peak detector response.

3.2.26 *instrument response time, n*—the time required for the electrical output of an opacity monitor to achieve 95 % of a step change in the path opacity.

3.2.27 *mean spectral response, n*—the mean response wavelength of the wavelength distribution for the effective spectral response curve of the transmissometer.

3.2.28 *optical alignment indicator, n*—a device or means to determine objectively the optical alignment status of opacity monitor components.

3.2.29 *peak spectral response, n*—the wavelength of maximum sensitivity of the transmissometer.

3.2.30 *photopic, n*—a region of the electromagnetic spectrum defined by the response of the light-adapted human eye as characterized in the “Source C, Human Eye Response” contained in 40CFR60, Appendix B, Performance Specification 1.

4. Summary of Practice

4.1 A comprehensive series of specifications and test procedures that opacity monitor manufacturers must use to certify opacity monitoring equipment (that is, that the equipment meets minimum design and performance requirements) prior to shipment to the end user is provided. The design and performance specifications are summarized in Table 1.

4.2 Design specifications and test procedures for (1) peak and mean spectral responses, (2) angle of view and angle of projection, (3) insensitivity to supply voltage variations, (4) thermal stability, (5) insensitivity to ambient light, and (6) an optional procedure for opacity monitors with external zero devices ~~that states or other which~~ regulatory agencies ~~might may~~ require are included. The manufacturer periodically selects and tests for conformance with these design specifications an instrument that is representative of a group of instruments) produced during a specified period or lot. Non-conformance with the design specifications requires corrective action and retesting. Each remanufactured opacity monitor must be tested to demonstrate conformance with the design specifications. The test frequency, transmissometer installation pathlength (that is, set-up distance) and pathlength correction factor for each design specification test are summarized in Table 2.

4.3 This practice includes manufacturer’s performance specifications and test procedures for (1) instrument response time, (2) calibration error, (3) optical alignment sight performance - homogeneity of light beam and detector. It also includes a performance check of the spectral response of the instrument. Conformance with these performance specifications is determined by testing each opacity monitor prior to shipment to the end user. (The validity of the results of the calibration error test depends upon the accuracy of the installation pathlength measurements, which is provided by the end user.) The test frequency, transmissometer installation pathlength (that is, set-up distance) and pathlength correction factor for each performance specification test are summarized in Table 3.

4.4 This practice establishes appropriate guidelines for QA programs for manufacturers of continuous opacity monitors, including corrective actions when non-conformance with specifications is detected.

5. Significance and Use

5.1 Continuous opacity monitors are required to be installed at many stationary sources of air pollution by federal, state, and local air pollution control agency regulations. EPA regulations regarding the design and performance of opacity monitoring systems for sources subject to “Standards of Performance for New Stationary Sources” are found in 40 CFR 60, Subpart A General Provisions, §60.13 Monitoring Provisions, Appendix B, Performance Specification 1, and in applicable source-specific subparts. Many states have adopted these or very similar requirements for opacity monitoring systems.

5.2 Regulated industrial facilities are required to report continuous opacity monitoring data to control agencies on a periodic basis. The control agencies use the data as an indirect measure of particulate emission levels and as an indicator of the adequacy of process and control equipment operation and maintenance practices.

5.3 EPA Performance Specification 1 provides minimum specifications for opacity monitors and requires source owners or operators of regulated facilities to demonstrate that their installed systems meet certain design and performance specifications. Performance Specification 1 ~~allows, as an alternative to testing each instrument, adopts this ASTM standard by reference so that manufacturers to~~ can demonstrate conformance with certain design specifications by selecting and testing representative instruments.

~~5.4 Previous experience has~~

~~5.4 Experience demonstrated that EPA Performance Specification 1~~ and prior to the August 10, 2000 revisions did not address all of the important design and performance parameters for opacity monitoring systems. The additional design and performance specifications included in this practice are needed to eliminate many of the performance problems that have been were previously encountered. This practice also provides purchasers and vendors flexibility, by designing the test procedures for basic transmissometer components or opacity monitors, or in certain cases, complete opacity monitoring systems. However, the specifications and test procedures are also sufficiently detailed to support the manufacturer’s certification and to facilitate independent third party evaluations (if desired) of the procedures used.

5.5 Purchasers of opacity monitoring equipment meeting all of the requirements of this practice are assured that the opacity monitoring equipment meets all of the design applicable requirements of EPA Performance Specification 1, ~~and additional design specifications that eliminate many of 1 for which the operational problems that have been encountered in the field.~~ manufacturer can certify conformance. Purchasers can rely on the manufacturer’s published operating range specifications for ambient temperature and supply voltage. These purchasers are also assured that the specific instrument has been tested at the point of manufacture and demonstrated to meet the manufacturer’s performance specifications for instrument response time, calibration error (based on pathlength measurements provided by the end user), optical alignment, and the spectral response performance

TABLE 1 Summary of Manufacturer's Specifications and Requirements

Specification	Requirement
Spectral response	peak and mean spectral response between 500 and 600 nm: less than 10% of peak response below 400 nm and above 700 nm
Angle of view, angle of projection	≤4° for all radiation above 2.5 % of peak
Insensitivity to supply voltage variations	±1.0 % opacity max. change over specified range of supply voltage variation, or ±10 % variation from the nominal supply voltage
Thermal stability	±2.0 % opacity change per 40°F change over specified operational range
Insensitivity to ambient light	±2.0 % opacity max. change from sunrise to sunset with at least one 1-h average solar radiation level of ≥ 900 W/m ²
External audit filter access	required
External zero device repeatability - Optional	±1.0 % opacity
Automated calibration checks	check of all active analyzer internal optics with power or curvature, all active electronic circuitry including the light source and photodetector assembly, and electric or electro-mechanical systems used during normal measurement operation
Simulated zero check device	simulated condition during which the energy reaching the detector is between 90 and 190 % of the energy reaching the detector under actual clear path conditions
Upscale calibration check device	check of the measurement system where the energy level reaching the detector is between the energy levels corresponding to 10 % opacity and the highest level filter used to determine calibration error
Status indicators	manufacturer to identify and specify
Pathlength correction factor security	manufacturer to specify one of three options
Measurement output resolution	0.5 % opacity over measurement range from -5 % to 50 % opacity, or higher value
Measurement and recording frequency	sampling and analyzing at least every 10 s: calculate averages from at least 6 measurements per minute
Instrument response time	≤10 s to 95 % of final value
Calibration error	≤3 % opacity for the sum of the absolute value of mean difference and 95 % confidence coefficient for each of three test filters
Optical alignment indicator - (uniformity of light beam and detector)	clear indication of misalignment at or before the point where opacity changes ±2 % due to misalignment as system is misaligned both linearly and rotationally in horizontal and vertical planes
Calibration device repeatability	≤1.5 % opacity

check requirement. Conformance with the requirements of this practice ensures conformance with all of the requirements of 40CFR60, Appendix B, Performance Specification 1 except those requirements for which tests are required after installation.

5.6 The original manufacturer, or those involved in the repair, remanufacture, or resale of opacity monitors can use this practice to demonstrate that the equipment components or opacity monitoring systems provided meet, or exceed, or both, appropriate design and performance specifications.

5.7 The applicable test procedures and specifications of this practice are selected to address the equipment and activities that are within the control of the manufacturer; they do not mandate testing of the opacity system data recording equipment or reporting.

TABLE 2 Manufacturer’s Design Specifications – Test Frequency, Set-Up Distance, and Pathlength Correction Factor

Manufacturer’s Design Specification	Test Frequency	Set-Up Distance	Pathlength Correction Factor
Spectral Response	annually, and following failure of spectral response performance check ^A	1 to 3 m when measured (not applicable when spectral response is calculated)	NA
Angle of view, angle of projection	monthly, or 1 in 20 units (whichever is more frequent)	3 m	NA
Insensitivity to supply voltage variations	monthly, or 1 in 20 units (whichever is more frequent)	3 m	1.0
Thermal stability	annually ^B	3 m (external jig for tests)	1.0
Insensitivity to ambient light	annually ^B	3 m	1.0
External zero device repeatability - optional	annually ^B	3 m	1.0
Additional design specifications ^C	as applicable		

^AThe spectral response is determined annually for each model and whenever there is a change in the design, manufacturing process, or component that might affect performance. Reevaluation of the spectral response is necessary when an instrument fails to meet the spectral response performance check.

^BAnnually, and whenever there is a change in the design, manufacturing process, or component that might affect performance.

^CThe manufacturer shall certify that the opacity monitor design meets the applicable requirements for (a) external audit filter access, (b) external zero device (if applicable), (c) simulated zero and upscale calibration devices, (d) status indicators, (e) pathlength correction factor security, (f) measurement output resolution, and (g) measurement recording frequency.

TABLE 3 Manufacturer’s Performance Specification – Test Applicability, Set-Up Distance and Pathlength Correction Factor

Manufacturer’s Performance Specification	Test Applicability	Set-Up Distance	Pathlength Correction Factor
Instrument response time	each instrument	per actual installation	per actual installation
Calibration error	each instrument	per actual installation ^A	per actual installation ^A
Acceptable tolerance comparing test to actual conditions		±10 % reset clear path zero values for subsequent monitoring ^B	±10 %, use actual value for all subsequent monitoring ^B
Optical alignment indicator - (uniformity of light beam and detector)	each instrument	per actual installation	per actual installation
Spectral response performance check	each instrument	per actual installation	per actual installation
Calibration device repeatability	each instrument	per actual installation	per actual installation

^A Default test values are provided for use where the installation pathlength and pathlength correction factor can not be determined.

^BWhen actual measurements are within ±10 % tolerance, a field performance audit can be performed rather than a field calibration error test at the time of installation.

5.8 This practice also may serve as the basis for third party independent audits of the certification procedures used by manufacturers of opacity monitoring equipment.

6. Procedure—Design Specification Verification

6.1 Test Opacity Monitor Selection, Test Frequency, and Summary of Tests:

6.1.1 Perform the design specification verification procedures in this section for each representative model or configuration involving substantially different optics, electronics, or software before being shipped to the end-user.

6.1.2 At a minimum, select one opacity monitor from each month’s production, or one opacity monitor from each group of twenty opacity monitors, whichever is more frequent. Test this opacity monitor for (1) angle of view, (2) angle of projection, and

(3) insensitivity to supply voltage variations. If any design specification is unacceptable, institute corrective action according to the established quality assurance program and remedy the cause of unacceptability for all opacity monitors produced during the month or group of twenty. In addition, test all of the opacity monitors in the group and verify conformance with the design specifications before shipment to the end-users.

NOTE 1—The selected opacity monitor may be the first opacity monitor produced each month, or the first opacity monitor in each group of twenty, provided that it is representative of the entire group.

6.1.3 At a minimum, test one opacity monitor each year for (1) spectral response, (2) thermal stability, and (3) insensitivity to ambient light. If any design specification is unacceptable, institute corrective action according to the established quality assurance program and remedy the cause of unacceptability for all affected opacity monitors. In addition, retest another representative opacity monitor after corrective action has been implemented to verify that the problem has been resolved.

6.1.4 Certify that the opacity monitor design meets the applicable requirements (see 6.7-6.13) for (1) external audit filter access, (2) external zero device (if applicable), (3) simulated zero and upscale calibration devices, (4) status indicators, (5) pathlength correction factor security, (6) measurement output resolution, and (7) measurement recording frequency. Maintain documentation of tests and data necessary to support certification.

6.2 Spectral Response:

NOTE 2—The purpose of the spectral response specifications is to ensure that the transmissometer measures the transmittance of light within the photopic range. The spectral response requirements ensure some level of consistency among opacity monitors because the determination of transmittance for effluent streams depends on the particle size, wavelength, and other parameters. The spectral response requirements also eliminate potential interfering effects due to absorption by various gaseous constituents except NO₂ which can be an interferent if present in abnormally high concentrations or over long pathlengths, or both. The spectral response requirements apply to the entire transmissometer. Any combination of components may be used in the transmissometer so long as the response of the entire transmissometer satisfies the applicable requirements.

6.2.1 *Test Frequency*— See 6.1.3. In addition, conduct this test (1) anytime a change in the manufacturing process occurs or a change in a component that may affect the spectral response of the transmissometer occurs or (2) on each opacity monitor that fails the spectral response performance check in 7.10.

6.2.2 *Specification*— The peak and mean spectral responses must occur between 500 nm and 600 nm. The response at any wavelength below 400 nm and above 700 nm must be less than 10 % of the peak spectral response. Calculate the mean spectral response as the arithmetic mean value of the wavelength distribution for the effective spectral response curve of the transmissometer.

6.2.3 *Spectral Response Design Specification Verification Procedure*—Determine the spectral response of the transmissometer by either of the procedures in 6.2.4 (Option 1) or 6.2.5 (Option 2), then calculate the mean response wavelength from the normalized spectral response curve according to 6.2.6. Option 1 is to measure the spectral response using a variable slit monochromator. Option 2 is to determine the spectral response from manufacturer-supplied data for the active optical components of the measurement system.

6.2.4 *Option 1, Monochromator*—Use the following procedure:

6.2.4.1 Verify the performance of the monochromator using a NIST traceable photopic band pass filter or light source, or both.

6.2.4.2 Set-up, optically align, and calibrate the transmissometer for operation on a pathlength of 1 to 3 m.

6.2.4.3 Connect an appropriate data recorder to the transmissometer and adjust the gain to an acceptable measurement level.

6.2.4.4 Place the monochromator in the optical path with the slit edge at an appropriate distance from the permanently mounted focusing lenses.

6.2.4.5 Use the monochromator with a range from 350 nm to 750 nm or greater resolution. Record the response of the transmissometer at each wavelength in units of optical density or voltage.

6.2.4.6 Cover the reflector for double-pass transmissometers, or turn off the light source for single-pass transmissometers, and repeat the test to compensate measurement values for dark current at each wavelength.

6.2.4.7 Determine the spectral response from the opacity monitor double pass response and the monochromator calibration.

6.2.4.8 Graph the raw spectral response of the transmissometer over the test range.

6.2.4.9 Normalize the raw response curve to unity by dividing the response at 10 nm intervals by the peak response.

6.2.5 *Option 2, Calculation from Manufacturer Supplied Data*—Obtain data from component suppliers that describes the spectral characteristics of the light source, detector, filters, and all other optical components that are part of the instrument design and affect the spectral response of the transmissometer. Ensure that such information is accurately determined using reliable means and that the information is representative of the specific components used in current production of the transmissometer under evaluation. Update the information at least every year or when new components are used, or both. Keep the information and records necessary to demonstrate its applicability to the current spectral response determination on file. Using the component manufacturer-supplied data, calculate the effective spectral response for the transmissometer as follows:

6.2.5.1 Obtain the spectral emission curve for the source. The data must be applicable for the same voltages or currents, or both, as that those used to power the source in the instrument.

6.2.5.2 Obtain the spectral sensitivity curve for the detector that is being used in the system.

6.2.5.3 Obtain spectral transmittance curves for all filters and other active optical components that affect the spectral response.

6.2.5.4 Perform a point-wise multiplication of the data obtained in 6.2.5.1-6.2.5.3, at 10 nm intervals, over the range 350 to 750

nm, to yield the raw response curve for the system.

6.2.5.5 Normalize the raw response curve to unity by dividing the response at 10 nm intervals by the peak response.

6.2.6 Using the results from Option 1 or 2, as applicable, determine conformance to the specifications in 6.2.2. Then calculate the mean response wavelength (response-weighted average wavelength) by (1) multiplying the response at 10 nm intervals by the wavelength, (2) summing all the products, and (3) dividing by the sum of all 10 nm interval responses. Verify that this result is greater than 500 nm but less than 600 nm.

6.2.7 *Monitor-Specific Performance Check Limits*—Establish the monitor-specific performance check limits for use in conducting the Spectral Response Performance Check (7.10) as follows:

NOTE 3—The equivalent single-pass opacity from 6.2.7.2 and the single-pass opacity results corresponding to the applicable shifts from 6.2.7.3 bound the acceptable limits for the spectral response performance check.

6.2.7.1 Obtain a ~~photopic~~ transmission filter that ~~has~~ (1) ~~a peak has monotonically decreasing transmission~~ $\geq 70\%$, (2) ~~maximum transmission between 550 nm and 560 nanometres,~~ ~~(3) half-maximum has transmission between greater than 80 % at 500 nm and 520 nm,~~ ~~(4) half-maximum has its 50 % transmission point between 600 nm and 620 nm,~~ ~~(5) has less than 20 % transmission~~ $< 10\%$ at any wavelength 600 nm and, (5) ~~has less than 450 nm or 5 % transmission at all wavelengths greater than 650 nm,~~ and (6) ~~a traceable calibration: 625 nm.~~ Such filters are widely available. Calibrate and verify the transmittance of the ~~photopic~~ filter as a function of wavelength initially and at least annually.

6.2.7.2 Calculate the expected single-pass opacity (assuming $PLCF=1$) that would result from inserting the ~~photopic~~ transmission filter into the clear-stack path of the transmissometer by (1) performing a point-wise multiplication of the ~~photopic square of the transmission filter curve with the normalized transmissometer response curve (obtained from 6.2.4.9 or 6.2.5.5);~~ ~~curve,~~ (2) summing the products, (3) dividing by the sum of the 10 nm responses to form the ~~single-pass double-pass transmission,~~ and (4) ~~calculating the single-pass transmission as the square root of the double pass transmission and,~~ (5) calculating the equivalent single-pass opacity.

6.2.7.3 Repeat the calculations in 6.2.7.2, except use (1) the normalized transmissometer curve shifted by +20 nm or the amount which would cause the peak or mean spectral response to shift to the limiting value of 600 nm, whichever shift is less, and (2) the normalized transmissometer curve shifted by -20 nm or the amount which would cause the peak or mean spectral response to shift to the limiting value of 500 nm, whichever shift is less.

6.2.7.4 Repeat the calculations with any design changes involving the source, detector(s), or light transmitting optics. Although failure of the spectral response performance check in 7.10 does not necessarily mean that the transmissometer response is no longer within the photopic range, it is a sufficient basis to warrant additional investigation, including reevaluation of the spectral response and performance check limits, explanation, and documentation of the problem.

6.3 *Angle of View and Angle of Projection :*

NOTE 4—The purpose of the angle of view (AOV) and angle of projection (AOP) design specifications is to minimize the effects of light scattering in the measurement path when determining transmittance or opacity.

6.3.1 *Test Frequency*— See 6.1.2. Manufacturers that demonstrate and document using good engineering practice that a specific design results in an AOP of less than 0.5° are not required to perform the following AOP or AOV tests.

6.3.2 *Specification*— The total AOP and the total AOV must each be no greater than 4° . Transmissometers with an AOP of less than 0.5° are exempt from the AOV or AOP specification.

6.3.3 *AOV and AOP Design Specification Verification Procedure*—Conduct the AOV and AOP tests using the procedures given in 6.3.4-6.3.13.

6.3.4 *Transmissometer Configuration* —Conduct the AOV and AOP tests with the complete transmissometer assembly, including all parts of the measurement system that may impact the results. Provide a justification of (1) exactly what is included and excluded from the AOV and AOP tests and (2) any test procedure modifications necessary to accommodate particular designs, such as those that may be required for dual beam designs that are chopped and synchronously detected. Include the justifications with documentation of the results.

6.3.5 *Set-Up*—Focus and configure the transmissometer for a flange-to-flange installation separation distance of 3 m.

6.3.6 *Test Fixture*— Set up the AOV test fixture that incorporates (1) a movable light source along arcs of ~~3 m radius relative equivalent to the first optical surface encountered by the light beam entering the detector housing assembly,~~ 3 m flange-to-flange installation separation distance, in both the horizontal and vertical directions relative to the normal installation orientation, and (2) recording measurements at 2.5 cm increments along the arc. Similarly, set up the AOP test fixture that incorporates (1) a movable photodetector along an arc of ~~3 m radius relative equivalent to the final optical surface encountered by the light beam exiting the transmitter housing assembly,~~ 3 m flange-to-flange separation distance in both the horizontal and vertical directions relative to the normal installation orientation, and (2) recording measurements at 2.5 cm increments along the arc.

NOTE 5—It is helpful to mount on test stands the detector and transmitter housings for single-pass transmissometers, or the transceiver for double-pass transmissometers.

6.3.7 *Alternative Test Fixture*—For the AOV test, at a distance ~~of equivalent to a 3 m flange-to-flange separation distance~~ from a stationary light source, mount the detector housing on a turntable that can be rotated (both horizontally and vertically) in increments of 0.5° [28.6 min], corresponding to measurements displaced 2.5 cm along the arc, to a maximum angle of 5°

(corresponding to a distance of 26 cm along the arc) on either side of the alignment centerline. Similarly, for the AOP test, mount transmitter housing on the turntable at a distance of equivalent to a 3 m flange-to-flange separation distance relative to a stationary photodetector.

NOTE 6—If the turntable is capable of rotating only in either the horizontal or vertical direction, the detector or transmitter housing may be mounted on its side or bottom (as appropriate) to simulate the other direction.

6.3.8 *Light Source*—For the AOV test, use a small non-directional light source (less than 3 cm wide relative to the direction of movement) that (1) includes the visible wavelengths emitted by the light source installed in the transmissometer, (2) provides sufficient illuminance to conduct the test but does not saturate the detector, (3) does not include lenses or focusing devices, and (4) does not include non-directional characteristics, that is, the intensity in the 20° sector facing the detector assembly varies by less than $\pm 10\%$.

NOTE 7—A light source that does not meet the non-directional criteria may still be used for the AOV test, if a specific procedure is followed. This procedure is given in 6.3.9.

6.3.9 *Alternative Light Source*—For the AOV test, if the light source does not meet the non-directional criteria, rotate the light source in the vertical and horizontal planes about its normal optical axis as it is pointed at the entrance aperture of the instrument under test in order to obtain the maximum response from the instrument under test at each position in the test procedure.

6.3.10 *AOV Test Procedure*—Test the entire detector assembly (that is, transceiver for double-pass transmissometers or receiver/detector for a single-pass transmissometer). If applicable, include the mounting flanges normally supplied with the opacity monitor. Use an appropriate data recorder to record continuously the detector response during the test.

NOTE 8—Alternative AOV test procedures are necessary for certain designs. For example, a transmissometer with an optical chopper/modulator responds only to light modulated at a certain frequency. An external chopper/modulator used in conjunction with the test light source must match both the phase and duty cycle for accurate results. If this cannot be done, the manufacturer may either (1) provide additional electronics to drive another similar external source in parallel with the internal source or (2) modify the detector electronics so that its response may be used to accurately evaluate the AOV of the test transmissometer. The manufacturer must take appropriate measures to ensure (1) that the background, or ambient light, and detector offsets do not significantly reduce the accuracy of the AOV measurements, (2) that the field of view restricting hardware normally included with the instrument are not modified in any way, and (3) that good engineering practice is followed in the design of the test configuration to ensure an accurate measurement of AOV.

6.3.10.1 Align the test light source at the center position and observe the detector assembly response. Optimize the test light source and optical chopper/modulator (if applicable) to maximize the detector assembly response. If the detector response is not within the normal operating range (that is, 25 to 200 % of the energy value equivalent to a clear path transmittance measurement for the transmissometer), adjust the test apparatus (for example, light source power supply) to achieve a detector response in the acceptable range.

6.3.10.2 Position the test light source on the horizontal arc 26 cm from the detector centerline (5°) and record the detector response. Move the light source along the arc at intervals not larger than 2.5 cm (or rotate the turntable in increments not larger than 0.5°) and record the detector response for each measurement location. Continue to make measurements through the aligned position and on until a position 26 cm (5°) on the opposite side of the arc from the starting position is reached. Record the response for each measurement location and over the full test range; continue recording data for all positions up to 26 cm (5°) even if no response is observed at an angle of ≤ 26 cm (5°) from the centerline.

6.3.10.3 Repeat the AOV test on an arc in the vertical direction relative to the normal orientation of the detector housing.

6.3.10.4 For both the horizontal and vertical directions, calculate the relative response of the detector as a function of viewing angle (response at each measurement location as a percentage of the peak response). Determine the maximum viewing angle for the horizontal and vertical directions yielding a response greater than 2.5 % of the peak response. Determine conformance to the specification in 6.3.2. Report these angles as the angle of view. Report the relative angle of view curves in both the horizontal and vertical directions. Document and explain any modifications to the test procedures as described in 6.3.11.

6.3.11 *AOP Test Procedure*—Perform this test for the entire light source assembly (that is, transceiver for double-pass transmissometers or transmitter for single-pass transmissometers). The test may also include the mounting flanges normally supplied with the opacity monitor. Conduct the AOP test using the procedures in either 6.3.12 or 6.3.13.

6.3.12 *Option 1*—Use a photodetector (1) that is less than 3 cm wide relative to the direction of movement, (2) that is preferably of the same type and has the same spectral response as the photodetector in the transmissometer, (3) that is capable of detecting 1 % of the peak response, and (4) that does not saturate at the peak illuminance (that is, when aligned at the center position of the light beam). Use an appropriate data recorder to record continuously the photodetector response during the test.

6.3.12.1 Perform this test in a dark room. If the external photodetector output is measured in a dc-coupled circuit, measure the ambient light level in the room (must be $< 0.5\%$ of the peak light intensity to accurately define the point at which 2.5 % peak intensity occurs). If the external photodetector is measured in an ac-coupled configuration, demonstrate that (1) ambient light level in the room, when added to the test light beam, does not cause the detector to saturate, and (2) turning on and off the ambient lights does not change the detected signal output. Include documentation for these demonstrations in the report.

6.3.12.2 Position the photodetector on the horizontal arc 26 cm from the projected beam centerline (5°) and record the response. Move the photodetector along the arc at ≤ 2.5 -cm intervals (or rotate the turntable in $\leq 0.5^\circ$ increments) until a position 26 cm (5°) on the opposite side of the arc is reached. Record the response for each measurement location and over the full test range; continue

recording data for all positions up to 26 cm (5°) even if no response is observed at an angle of ≤ 26 cm (5°) from the centerline.

6.3.12.3 Repeat the AOP test on an arc in the vertical direction relative to the normal orientation of the detector housing.

6.3.12.4 For both the horizontal and vertical directions, calculate the relative response of the photodetector as a function of projection angle (response at each measurement location as a percentage of the peak response). Determine the maximum projection angle for the horizontal and vertical directions yielding a response greater than 2.5 % of the peak response. Determine conformance to the specification in 6.3.2. Report these angles as the angle of projection. Report the relative angle of projection curves in both the horizontal and vertical directions.

6.3.13 *Option 2*—Use this test procedure for only transmissometer designs that have previously met the AOP specification using Option 1 procedure during the preceding 12 months. Ensure that the light beam is focused at the actual flange-to-flange separation distance of the transmissometer.

6.3.13.1 Perform this test in a darkened room. Project the light beam onto a target located at a distance of 3 m from the transceiver/transmitter. Focus the light beam on the target.

6.3.13.2 Measure the beam dimensions (for example, diameter) on the target in both the horizontal and vertical directions. Calculate the maximum total angle of projection (that is, total subtended angle) based on the separation distance and beam dimensions. Compare this result to the previously measured AOP result obtained using Option 1. If the AOP results obtained by Option 1 and Option 2 do not agree within $\pm 0.3^\circ$, repeat the test using Option 1.

6.3.13.3 Report the greater AOV result of Option 1 or Option 2 as the AOV for the test instrument.

6.4 *Insensitivity to Supply Voltage Variations:*

NOTE 9—The purpose of this design specification is to ensure that the accuracy of opacity monitoring data is not affected by supply voltage variations over ± 10 % from nominal or the range specified by the manufacturer, whichever is greater. This specification does not address rapid voltage fluctuations (that is, peaks, glitches, or other transient conditions), emf susceptibility or frequency variations in the power supply.

6.4.1 *Test Frequency*— See 6.1.2.

6.4.2 *Specification*— The opacity monitor output (measurement and calibration check responses, both with and without compensation, if applicable) must not deviate more than ± 1.0 % single pass opacity for variations in the supply voltage over ± 10 % from nominal or the range specified by the manufacturer, whichever is greater.

6.4.3 *Design Specification Verification Procedure:*

6.4.3.1 Determine the acceptable supply voltage range from the manufacturer's published specifications for the model of opacity monitor to be tested. Use a variable voltage regulator and a digital voltmeter to monitor the rms supply voltage to within ± 0.5 %. Measure the supply voltage over ± 10 % from nominal, or the range specified by the manufacturer, whichever is greater.

6.4.3.2 Set-up and align the opacity monitor (transceiver and reflector for double-pass opacity monitors, or transmitter and receiver for single-pass opacity monitors) at a measurement flange-to-flange separation pathlength of 3 m. Use a pathlength correction factor of 1.0. Calibrate the instrument using external attenuators at the nominal operating voltage. Insert an external attenuator with a nominal value between 10 and 20 % single-pass opacity into the measurement path and record the response. Initiate a calibration check cycle and record the low level and upscale responses.

6.4.3.3 Do not initiate any calibration check cycle during this test procedure except as specifically required. Decrease the supply voltage from nominal voltage to minimum voltage in at least five evenly spaced increments of 2 % of the nominal value and record the one-minute or more frequent stable measurement response to the attenuator at each voltage (after the instrument response has stabilized) until the minimum value is reached. voltage. Initiate a calibration check cycle at the minimum supply voltage and record the low level and upscale responses. Reset the supply voltage to the nominal ~~value and then increase~~ value. Increase the supply voltage from nominal voltage to maximum voltage in at least five evenly spaced increments of 2 % of the nominal value and record the stable measurement response to the attenuator at each voltage (after the instrument response has stabilized) until the maximum value is reached. voltage. Initiate a calibration check cycle at the maximum supply voltage and record the low level and upscale responses, both with and without compensation, if applicable.

6.4.3.4 Determine conformance to specifications in 6.4.2.

6.5 *Thermal Stability:*

NOTE 10—The purpose of this design specification is to ensure that the accuracy of opacity monitoring data is not affected by ambient temperature variations over the range specified by the manufacturer.

6.5.1 *Test Frequency*— See 6.1.3. Repeat this test anytime there is a major change in the manufacturing process or change in a major component that could affect thermal stability.

6.5.2 *Specification*— The opacity monitor output ~~output~~ (measurement and calibration check responses, both with and without compensation, if applicable) must not deviate more than ± 2.0 % single pass opacity for every 22.2°C (40°F) change in ambient temperature over the range specified by the manufacturer.

6.5.3 *Design Specification Verification Procedure:*

6.5.3.1 Determine the acceptable ambient temperature range from the manufacturer's published specifications for the model of opacity monitor to be tested. Use a climate chamber capable of operation over the specified range. If the climate chamber cannot achieve the full range (for example, cannot reach minimum temperatures), clearly state the temperature range over which the opacity monitor was tested and provide additional documentation of performance beyond this range to justify operating at lower temperatures.

6.5.3.2 Set-up and align the opacity monitor (transceiver and reflector for double-pass opacity monitors, or transmitter and receiver for single-pass opacity monitors) at a ~~measurement pathlength~~ flange-to-flange separation distance of 3 m. Use a pathlength correction factor of 1.0. If the opacity monitor design introduces purge air through the housing that contains optical components of the transceiver, transmitter, or detector, operate the purge air system during this test. If the purge air does not contact internal optics and electronics, the air purge system need not be operative during the test.

NOTE 11—For double-pass systems with reflectors that can be shown to be insensitive to temperature, this test may be performed using a zero reference similar to an external zero jig, but one that is designed specifically to evaluate the temperature stability of the instrument for this test. This device must be designed to be temperature invariant so that the test evaluates the stability of the instrument, not the stability of the zero reference. Another acceptable approach is to construct a test chamber where the reflector is mounted outside the chamber at a constant temperature. The control unit, if applicable, need not be installed in the climate chamber if it is to be installed in a controlled environment by the end user.

6.5.3.3 Establish proper calibration of the instrument using external attenuators at a moderate temperature that is, $21.1 \pm 2.8^\circ\text{C}$ ($70 \pm 5^\circ\text{F}$). Insert an external attenuator with a single-pass value between 10 and 20 % opacity into the measurement path and record the response. Initiate a calibration check cycle and record the low level and upscale responses.

NOTE 12—Grid filters are recommended for these tests to eliminate temperature dependency of the attenuator value.

6.5.3.4 Do not initiate any calibration check cycle during this test procedure except as specifically stated. Continuously record the temperature and measurement response to the attenuator during this entire test. Decrease the temperature in the climate chamber at a rate not to exceed 11.1°C (20°F) per hour until the minimum temperature is reached. Note data recorded during brief periods when condensation occurs on optical surfaces due to temperature changes. Allow the opacity monitor to remain at the minimum temperature for at least one hour and then initiate a calibration check cycle and record the low level and upscale responses with and without compensation, if applicable. Return the opacity monitor to the initial temperature and allow sufficient time for it to equilibrate and for any condensed moisture on exposed optical surfaces to evaporate. Increase the temperature in the climate chamber at a rate not to exceed 11.1°C (20°F) per hour until the maximum temperature is reached. Allow the opacity monitor to remain at the maximum temperature for at least one hour and then initiate a calibration check cycle and record the low level and upscale responses.

NOTE 13—The notations when condensation occurs are for explanatory purposes only.

6.5.3.5 Determine conformance to specifications in 6.5.2.

6.6 *Insensitivity to Ambient Light* :

NOTE 14—The purpose of this design specification is to ensure that opacity monitoring data are not affected by ambient light.

6.6.1 *Test Frequency*— See 6.1.3. Repeat this test anytime there is a major change in the manufacturing process or change in a ~~major~~ critical component that could affect the opacity monitor sensitivity to ambient light.

6.6.2 *Specification*— The opacity monitor output ~~(measurement (including zero and upscale reference calibration check responses, both with values, and without compensation, if applicable) normal measurements of an upscale filter value)~~ must not deviate more than ± 2.0 % single pass opacity when exposed to ambient sunlight over an artificial light source described herein as compared to the course effect of normal room lighting. This artificial light source is deemed to be sufficiently equivalent to solar radiation to be used for the purpose of demonstrating insensitivity to ambient outdoor light.

6.6.3 *Design Specification Verification Procedure:*

6.6.3.1 Perform this test ~~(1) at a time of maximum insolation, on a clear day where light scattering from atmospheric haze, clouds, or particulate matter are at a minimum, (2) when at least one 1-h solar radiation average is $\geq 900 \text{ W/m}^2$, and (3) for a specific opacity monitor that has previously successfully completed the spectral response, thermal stability tests, and other design specification verification procedures.~~

6.6.3.2 Set-up the opacity monitor ~~outside~~, with the monitor's light path in a horizontal position, and where it will be directly exposed to sunlight for the entire day. plane. Use mounting tubes and mounting flanges of normal length; and diameter per standard manufacturer's instructions, and attach the flanges to mounting plates that extend at least 0.305 m (12 in.) above, below, and to both sides of the mounting flanges. These plates simulate the inside surfaces of the stack or duct of a typical installation configuration. Paint the interior surfaces of the mounting tubes, flanges and the facing surfaces of the mounting plates white. Optically align the opacity monitor (transceiver and reflector for double-pass opacity monitors, or transmitter and receiver for single-pass opacity monitors) at a measurement flange-to-flange pathlength of 3 m on an approximate east-west axis aligned with the transit of the sun. m. Use a pathlength correction factor of 1.0. Calibrate the instrument using external attenuators appropriate for a 20 % opacity limit prior to the test. Insert an external attenuator with a single-pass value between 10 and 20 % opacity into the measurement path and record the response. Initiate a calibration check cycle and record the low level and upscale responses. These measurements, taken using normal room lighting constitute the reference readings against which subsequent readings will be compared. In all cases, document whether readings are taken with or without zero compensation.

6.6.3.3 Use a cosine corrected total solar radiation monitor that (1) is capable of detecting light from 400 to 1100 nm, (2) has been calibrated under natural daylight conditions to within ± 5 % against industry standards, (3) has a sensitivity of at least $90.75 \mu\text{A}/100 \text{ W/m}^2$, and (4) has a linearity with a maximum deviation of less than 1 % up to 3000 W/m^2 . Place Mount the solar radiation monitor on top the white surface simulating the inside of the stack on the transceiver side (for double-pass opacity monitors;) or detector side mounting plate (for single-pass opacity monitors. If weather covers are supplied with all opacity monitors, install

monitors) such that the solar radiation monitor on top is aligned parallel to the measurement beam of the weather cover. Measure opacity monitor as close to the total solar radiation according optical axis as is practical without obstructing the measurement beam, aligned parallel to the manufacturer's instructions.

6.6.3.4 Continuously record optical axis of the opacity monitor.

6.6.3.4 Using a halogen lamp spotlight with nominal color temperature of 2950 Kelvin, illuminate the transceiver (for double-path models) or the detector (for single-path models) such that the radiation monitor indicates a light intensity of at least 900 watts/m² for light that has passed through a Schott K4 filter (or equivalent with transmission within 20 % of the attenuator transmission of the Schott filter for all wavelengths between 400 nm and 1100 nm). A suitable spotlight for this purpose is a halogen 1000-watt bulb on a flagpole fixture. The opacity manufacturer may, at its discretion, place the output of filter over the lamp, such that all the emitted light is filtered (which subjects the opacity monitor to light with a color temperature reasonably equivalent to mid-morning or mid-afternoon solar radiation) or only over the radiation detector (which subjects the opacity monitor for to more total radiation, but permits use of a smaller, less expensive filter). The spotlight must be directed from two hours before sunrise to two hours after sunset. Record a location in the ambient temperature during vertical plane above the measurement beam of the opacity monitor: Within this period. Do not conduct calibration check cycles during this test more frequently than once per 24-h period vertical plane, the opacity manufacturer may direct the spotlight at the front of the transceiver (or detector) at any angle or from any distance, provided that the longest interval recommended illuminated area is at least 0.35 m in the manufacturer's published specifications. Document diameter and report is centered on the frequency optical axis of conducting calibration check cycles during the insensitivity opacity monitor.

6.6.3.5 Record the opacity monitor response, in the presence of the added radiation to ambient light test.

6.6.3.5 If necessary, correct the measurement attenuator. Remove the attenuator and initiate a calibration check cycle, recording the upscale and zero response in instrument the presence of the added radiation. Switch the spotlight off and record the response due to ambient temperature variation by running a separate test the attenuator.

6.6.3.6 Repeat steps 6.6.3.3 through 6.6.3.5 with the same instrument shielded from solar radiation monitor similarly mounted on the sunlight. Determine other mounting plate and the maximum percent deviation in spotlight illuminating the measurement response for any six minute period during retroreflector (for double-pass monitors) or the source (for single pass instruments).

6.6.3.6.7 Determine conformance with the specifications 6.6.2 by calculating the change in the reading of the upscale fixture due to the effect of the spotlight, from the normal measurements recorded in 6.6.3.2. Separately record the effect with the spotlight illuminating each of the sides of the opacity monitor set-up. Neither of the sets of tests may result in more than a 2 % change in the reading.

6.7 External Audit Filter Access :

NOTE 15—The opacity monitor design must accommodate independent assessments of the measurement system response to commercially available external (that is, not intrinsic to the instrument) audit filters. These calibration attenuators may be placed within the mounting flange, air purge plenum, or other location after the projected light beam passes through the last optical surface of the transceiver or transmitter. They may also be placed in a similar location at the other end of the measurement path prior to the light beam reaching the first optical surface of the reflector or receiver. The external audit filter access design must ensure (a) the filters are used in conjunction with a zero condition based on the same energy level, or within 5 % of the energy reaching the detector under actual clear path conditions, (b) the entire beam received by the detector will pass through the attenuator, and (c) the attenuator is inserted in a manner that minimizes interference from the reflected light.

6.7.1 Insert the external audit filter into the system.

6.7.2 Determine whether the entire beam received by the detector passes through the attenuator and that interference from reflected light is minimal.

6.7.3 Determine whether the zero condition corresponds to the same energy level reaching the detector as when actual clear path conditions exist

6.8 External Zero Device—Optional :

NOTE 16—The opacity monitor design may include an external, removable device for checking the zero alignment of the transmissometer. Such a device may provide an independent means of simulating the zero opacity condition for a specific installed opacity monitor over an extended period of time and can be used by the operator to periodically verify the accuracy of the internal simulated zero device. The external zero device must be designed: (1) to simulate the zero opacity condition based on the same energy level reaching the detector as when actual clear path conditions exist; (2) to produce the same response each time it is installed on the transmissometer; and (3) to minimize the chance that inadvertent adjustments will affect the zero level response produced by the device. The opacity monitor operator is responsible for the proper storage and care of the external zero device and for reverifying the proper calibration of the device during all clear path zero alignment tests.

NOTE 17—The purpose of this design specification is to ensure that the external zero device design and mounting procedure will produce the same response each time that the device is installed on the transmissometer.

6.8.1 *Test Frequency*— If the optional external zero device is supplied with any opacity monitors of the subject model, select and perform this test for one representative external zero device manufactured each year for the opacity monitor model certified by this practice.

6.8.2 *Specification*— The opacity monitor output must not deviate more than ± 1.0 % single pass opacity for repeated installations of the external zero device on a transmissometer.

6.8.3 *Design Specification Verification Procedure*—Perform this test using an opacity monitor that has successfully completed the tests to demonstrate insensitivity to ambient light (6.6) and which is set up and properly calibrated for a measurement

~~pathlength~~ flange-to-flange separation distance of 3 ~~meters~~, m. Install the external zero device and make any necessary adjustment to it so that it produces the proper zero opacity response from the test transmissometer. Remove the external zero device and return the test transmissometer to operation and verify that the opacity monitor output indicates $0.0 \pm 0.5\%$ opacity. Without making any adjustments to the external zero device or the test opacity monitor, install and remove the external zero device five times. Record the zero response of the test opacity monitor to the external zero device and to the clear path condition after it is returned to operation after each installation.

6.8.4 Determine conformance with the design specification in 6.8.3.

6.9 Calibration Check Devices:

NOTE 18—Opacity monitors covered by this practice must include automated mechanisms to provide calibration checks of the installed opacity monitor.

6.9.1 *Simulated Zero Device*—Establish the proper response to the simulated zero device under clear path conditions while the transmissometer is optically aligned at the installation pathlength and accurately calibrated. Certify that the simulated zero device conforms to the following:

6.9.1.1 The simulated zero device produces a simulated clear path condition or low level opacity condition, where the energy reaching the detector is between 90 and 190 % of the energy reaching the detector under actual clear path conditions. Corrections for energy levels other than 100 % are permitted provided that they do not interfere with the instrument's ability to measure opacity accurately.

6.9.1.2 The simulated zero device provides a check of all active analyzer ~~internal optics with power or curvature, optics,~~ all active electronic circuitry including the light source and photodetector assembly, and electric or electro-mechanical systems, and hardware ~~and~~, or software, or both, used during normal measurement operation.

NOTE 19—The simulated zero device allows the zero drift to be determined while the instrument is installed on the stack or duct. Simulated zero checks, however, do not necessarily assess the optical alignment, status of the reflector (for double-pass systems), or the level of dust contamination of all optical surfaces.

6.9.2 *Upscale Calibration Device* —Certify that the device conforms to the following:

6.9.2.1 The upscale calibration device measures the upscale calibration drift under the same optical, electronic, software, and mechanical components as are included in the simulated zero check.

6.9.2.2 The upscale calibration device checks the pathlength corrected measurement system response where the energy level reaching the detector is between the energy levels corresponding to 10 % opacity and the highest level filter used to determine calibration error.

6.9.2.3 The upscale calibration check response is not altered by electronic hardware or software modification during the calibration cycle and is representative of the gains and offsets applied to normal effluent opacity measurements.

NOTE 20—The upscale calibration device may employ a neutral density filter or reduced reflectance device to produce an upscale drift check of the measurement system. The upscale calibration device may be used in conjunction with the simulated zero device (for example, neutral density filter superimposed on simulated zero reflector) or in a parallel fashion (for example, zero and upscale [reduced reflectance] devices applied to the light beam sequentially).

6.10 Status Indicators:

NOTE 21—Opacity monitors must include alarms or fault condition warnings to facilitate proper operation and maintenance of the opacity monitor. Such alarms or fault condition warnings may include lamp/source failure, purge air blower failure, excessive zero or calibration drift, excessive zero or dust compensation, and so forth.

6.10.1 Specify the conditions under which the alarms or fault condition warnings are activated.

6.10.2 Verify the conditions of activations in 6.10.1 on an annual basis.

6.10.3 Certify that the system's visual indications, or audible alarms, as well as electrical outputs can be recorded as part of the opacity data record and automatically indicate when either of the following conditions are detected:

6.10.3.1 A failure of a sub-system or component which can be reasonably expected to invalidate the opacity measurement, or

6.10.3.2 A degradation of a subsystem or component which requires maintenance to preclude resulting failure.

6.11 *Pathlength Correction Factor (PLCF) Security:* ~~NOTE 22—The opacity monitoring system must display and record all measured opacity values (including effluent opacity measurements, zero and upscale calibration checks, and zero or dust compensation values) corrected to the emission outlet pathlength.~~

6.11.1 Certify that the system opacity monitor has been designed and constructed so that the value of the pathlength correction factor

6.11.1.1 Cannot be changed by the end user without assistance from the manufacturer, or

6.11.1.2 Is available to be recorded during each calibration check cycle, or

6.11.1.3 The ~~system must~~ opacity monitor provides an alarm when the value is changed from the certified value.

6.11.2 Document the option(s) that are selected and write corresponding instructions. Provide them to the end user to minimize the likelihood that the PLCF will be changed inadvertently.

6.12 Measurement Output Resolution :

6.12.1 Certify that the opacity monitor output, including visual measurement displays, analog outputs, or digital outputs, or

combinations thereof, have a resolution ≤ 0.5 % opacity over the measurement range from -4.0 % opacity to 50 % opacity or higher value.

NOTE 232—The 0.5 % opacity resolution is required for determining calibration error or achieving conformance with applicable regulatory requirements.

6.13 Measurement and Recording Frequency :

6.13.1 Certify that each opacity monitor is designed and constructed to do the following:

6.13.1.1 To complete a minimum of one cycle of sampling and analyzing for each successive 10-s period.

6.13.1.2 To calculate average opacity values from 6 or more data points equally spaced over each 1-min period included in the average (for example, 6 measurements per 1-min average or 36 measurements per 6-min average),

6.13.1.3 To record values for each averaging period.

NOTE 243—Most regulations require recording of six-min average opacity values, however, some regulatory agencies require calculation of one-minute or other less than 6-min average values.

7. Procedure—Manufacturer’s Performance Specifications

7.1 *Required Performance Tests*—Test each instrument prior to shipment to ensure that the opacity monitor meets manufacturer’s performance specifications for instrument response time, calibration error, and optical alignment sight performance. Conduct a performance check of the spectral response for each instrument.

NOTE 254—These tests are performed for the specific transmissometer components (transceiver and reflector for double-pass opacity monitors or transmitter and receiver for single-pass opacity monitors), the specific control unit (if included in the installation), and any other measurement system components that are supplied by the manufacturer. The data recording system that will be employed by the end user is not required to be evaluated by these tests. Additional field tests are necessary to evaluate the complete opacity monitoring system after it is installed at the end user’s facility. The field test procedures may be simplified when certain conditions are met in the conduct of the manufacturer’s performance specification tests.

7.2 Representative Test Conditions :

7.2.1 Conduct the manufacturer’s performance specification tests under conditions that are representative of the specific intended installation, whenever possible. Obtain from the end user accurate information about the installation pathlength (that is, flange-to-flange separation distance), monitoring pathlength, emission outlet pathlength, and the applicable opacity standard. Use the applicable opacity standard, monitoring pathlength, and emission outlet pathlength to select appropriate attenuators for the calibration error test and to establish the pathlength correction factor for the opacity monitor being tested. Set-up and test the transmissometer components at the same installation pathlength and the same pathlength correction factor as that of the field installation.

NOTE 265—When these conditions are met, the equivalent *clear path* setting for an external zero device can be established in conjunction with the manufacturer’s calibration error test. This device can then be used in subsequent field calibration error tests to verify performance of the opacity monitor. If both the actual installation pathlength and the pathlength correction factors are within ± 10 % of the values used for the manufacturer’s calibration error test, the manufacturer’s calibration error test results are valid and representative for the installation.

7.2.2 If actual pathlength values differ by >2 %, but ≤ 10 % relative to that used for the manufacturer’s calibration error test, repeat the zero alignment (for installation pathlength errors) or reset the pathlength correction factor (for pathlength correction errors) prior to subsequent opacity monitoring.

NOTE 276—A field performance audit may be substituted for the field calibration error test when the above criteria are satisfied.

7.2.3 If the actual installation pathlength, or pathlength and pathlength correction factors, or both, exceed ± 10 % of the values used for the manufacturer’s calibration error test, repeat the calibration error test.

7.3 *Default Test Conditions*—If the installation pathlength, monitoring pathlength, and emission outlet pathlength cannot be determined by the manufacturer (for example, opacity monitor is intended for future resale, opacity monitor will serve as backup for multiple installations, construction of facility is not complete and so forth), test the opacity monitor at a flange-to-flange installation pathlength of 5.3 m and use a pathlength correction factor of 1.0. ~~If an opacity monitor is designed for a range of measurement pathlengths that does not include 5 m, test the opacity monitor at the middle of the range specified by the manufacturer (see example in Note 28). If the applicable opacity standard cannot be determined, assume a standard of 20 % opacity for the selection of attenuators used for the calibration error test.~~ NOTE 28—~~Example: If an opacity monitor is designed for measurement pathlengths from 6 to 12 m, use a pathlength of 9 m.~~

7.4 *Test Set-Up*—Conduct the performance tests of the opacity monitor in a clean environment in an area protected from manufacturing or other activities that create dust, mist, fumes, smoke, or any other ambient condition that will interfere with establishing a clear path opacity condition.

7.4.1 Set-up the transmissometer components on test stands that will facilitate adjustments to, and maintenance of, the optical alignment throughout the test procedure.

7.4.2 Use the appropriate installation pathlength as determined from 7.2, if possible, or 7.3, if necessary.

7.4.3 Adjust the focus of the transmissometer for the installation pathlength, if applicable.

7.4.4 Optically align the transmissometer components according to the written procedures of the manufacturer.

7.4.5 Verify that the alignment sight indicates proper alignment.

7.4.6 Enter the proper pathlength correction factor (if applicable) for the opacity monitor.

7.4.7 Establish proper calibration of the measurement system according to the manufacturer’s written procedures.

7.4.8 Connect the opacity monitor to an appropriate data recorder for documenting the performance test results. At a minimum, use a data recorder that

7.4.8.1 Is capable of resolving 0.25 % opacity,

7.4.8.2 Has been accurately calibrated and verified according to the manufacturer’s QA procedures, and

7.4.8.3 Has a sufficiently fast response to measure the instrument response time.

7.5 *Selection of Calibration Attenuators*—Using the applicable pathlength correction factor and opacity standard values from 7.2 (if possible) or 7.3 (if necessary), select calibration attenuators that will provide an opacity monitor response corrected to single-pass opacity values for the emission outlet pathlength in accordance with the following:

Applicable Standard	10 to 19 % opacity	≥20 % opacity
Low-level:	5 to 10 %	10 to 20 %
Low level:	5 to 10 % opacity	10 to 20 % opacity
Mid-level:	10 to 20 %	20 to 30 %
Mid level:	10 to 20 % opacity	20 to 30 % opacity
High-level:	20 to 40 %	30 to 60 %
High level:	20 to 40 % opacity	30 to 60 % opacity

NOTE 297—The manufacturer may elect to use additional calibration attenuators in the calibration error test. The use of additional calibration attenuators may be advantageous in demonstrating the linear range of the measurement system. Alternate calibration attenuator values may be used where required by applicable regulatory requirements (for example, state or local regulations, permit requirements, and so forth).

7.6 *Attenuator Calibrations*—Calibrate the attenuators used for the manufacturer’s calibration at the frequency and according to the procedures specified in 40 CFR 60, Appendix B, Performance Specification 1, paragraph 7.1 or 7.32. For transmissometers operating over narrow bandwidths, determine the attenuator calibration values for the actual operating wavelengths of the transmissometer.

7.7 *Instrument Response Time:*

NOTE 30—~~The 28—~~The purpose of the instrument response time test is to demonstrate that the instantaneous output of the opacity monitor is capable of tracking rapid changes in effluent opacity, using when the instantaneous output or signal input is used to generate averages. It includes the transmissometer components and the control unit if one is included for the particular installation. The instrument response time test does not include the opacity monitoring system permanent data recorder. (A separate field test should be conducted to verify the ability of the system to properly average or integrate and record 6-min opacity values.)

7.7.1 *Specification*— The instrument response time must be less than or equal to 10 s.

7.7.2 *Instrument Response Time Test Procedure* —The test shall be performed with all opacity monitor internal settings, adjustments or software values, or both which affect the opacity monitor time constant, response time, or data averaging set at the same positions or values as to be used for effluent monitoring. The internal settings, or software values, or both, used for the response time test shall be recorded and reported with the response time test results. Using a high-level calibration attenuator, alternately insert the filter five times and remove it from the transmissometer light path.

7.7.2.1 For each filter insertion and removal, determine the amount of time required for the opacity monitor to display 95 % of the step change in opacity on the data recorder used for the test. For upscale response time, determine the time it takes to reach 95 % of the final, steady upscale reading. For downscale response time, determine the time it takes for the display reading to fall to 5 % of the initial upscale opacity reading.

7.7.2.2 Calculate the mean of the five upscale response time measurements and the mean of the five downscale response time measurements. Report each of the upscale and downscale response time determinations and the mean upscale and downscale response times.

7.7.3 Determine conformance with the specification in 7.7.1. If the response time is not acceptable, take corrective action and repeat the test.

7.8 *Calibration Error:*

NOTE 31—~~The 29—~~The calibration error test is performed to demonstrate that the opacity monitor is properly calibrated and can provide accurate and precise measurements.

7.8.1 *Specification*— The calibration error must be ≤3 % opacity as calculated ~~and~~ as the sum of the absolute value of the mean difference and confidence coefficient for each of three test attenuators.

7.8.2 *Calibration Error Test Procedure :*

7.8.2.1 Zero the instrument. Insert the calibration attenuators (low-, mid- and high-level) into the light path between the transceiver and reflector (or transmitter and receiver).

7.8.2.2 While inserting the attenuator, ensure that the entire beam received by the detector passes through the attenuator and insert the attenuator in a manner that minimizes interference from the reflected light.

NOTE 320—See also Note 15. The placement and removal of the attenuator must be such that measurement of opacity is performed over a sufficient period to obtain a stable response from the opacity monitor.

7.8.2.3 Make a total of five non-consecutive readings for each filter. Record the opacity monitoring system output readings in single-pass percent opacity.

7.8.2.4 Subtract the single-pass calibration attenuator values corrected to the stack exit conditions from the opacity monitor responses. Calculate the arithmetic mean difference, standard deviation, and confidence coefficient of the five measurements value. Calculate the calibration error as the sum of the absolute value of the mean difference and the 95 % confidence coefficient for each of the three test attenuators. Report the calibration error test results for each of the three attenuators.

$$\bar{x} = \frac{1}{n} \sum_{i=1}^n x_i \quad (4)$$

where:

\bar{x} = arithmetic mean,
 x_i = individual measurements, and
 n = number of data points.

$$S_d = \sqrt{\frac{\sum_{i=1}^n x_i^2 - \frac{(\sum_{i=1}^n x_i)^2}{n}}{n-1}} \quad (5)$$

where:

s_d = standard deviation.

$$CC = t_{0.975} \frac{S_d}{\sqrt{n}} \quad (6)$$

where:

$t_{0.975}$ = t-value ($t_{0.975} = 2.776$ for $n = 5$), and
 CC = confidence coefficient

7.8.2.5 Determine conformance with the specification in 7.8.1. If the calibration error test results are not acceptable, take corrective action, recalibrate the opacity monitor according to the manufacturer's written instructions, and repeat the calibration error test.

7.9 Optical Alignment Indicator – (Uniformity of Light Beam and Detector):

NOTE 331—Each transmissometer must provide a means for visually determining that the instrument is optically aligned. The purpose of this specification is to ensure that the alignment device is capable of clearly indicating when the transmissometer components are misaligned. The performance test procedure will also detect opacity monitors where the accuracy of opacity measurements is adversely affected by the use of the light beams having non-uniform intensity, or the use of non-uniform detectors, or inefficient or poor quality retro-reflector material.

7.9.1 *Specification*— The alignment sight must clearly indicate that the unit is misaligned when an error of $\pm 2\%$ single-pass opacity occurs due to shifts in the optical alignment of the transmissometer components. For opacity monitor designs that include automatic beam steering (that is beam position sensing and an active means for adjusting alignment so that centered alignment is maintained even with slowly changing misalignment conditions), an alarm must be activated when the alignment is varied beyond the manufacturer's specified range of angular tolerance is unable to maintain alignment.

NOTE 342—Modifications of the alignment indicator test procedures for systems with beam steering are included in 7.9.7.

7.9.2 *Alignment Indicator Performance Test Procedure*—Conduct the alignment indicator test according to the procedures in 7.9.3-7.9.7.

NOTE 353—The test procedure can be modified to accommodate moving of either component of the transmissometer to achieve equivalent geometric misalignment as described in 7.9.3-7.9.6. Alignments tests may be performed in the horizontal or vertical planes of the instrument and the instrument components may be turned on their side to accommodate the tests.

7.9.3 Set-up:

7.9.3.1 Set up the transmissometer on test stands that allow adjustments for the rotational and translational misalignment tests.

7.9.3.2 Optically align the transceiver and reflector (double-pass opacity monitor) or transmitter and receiver (single-pass opacity monitor) according to the manufacturer's written instructions. Verify that all alignment indicator devices show proper alignment.

7.9.3.3 Conduct the alignment indicator performance test with a clear path condition. Alternatively, insert an external attenuator that produces a response $\leq 10\%$ single-pass opacity into the measurement path turn it approximately 3° from normal to the light path to eliminate surface reflection, and record the indicated opacity.

7.9.4 Case 1: Single and Double Pass Opacity Monitors:

7.9.4.1 Slowly tilt the transceiver (double-pass opacity monitor) or transmitter (single-pass opacity monitor) upward in the vertical plane (for example, adjust the appropriate alignment bolts or mounting mechanism) relative to the reflector (double-pass opacity monitor) or receiver (single-pass opacity monitor) until an error of $\pm 2\%$ opacity is first indicated on the data recorder. Verify that the alignment indicator shows misalignment.

7.9.4.2 Illustrate and record the alignment indicator and the degree of misalignment shown.

7.9.4.3 Return the system to its aligned condition.

7.9.4.4 Repeat the entire procedure by tilting the transceiver in the opposite (downward) direction.

7.9.4.5 Repeat the rotational misalignment check of the transceiver or transmitter in the horizontal plane (both to the left and right) and again illustrate and record the visual depiction of the alignment for each step of the procedure.

7.9.5 *Case 2, Single-Pass Opacity Monitors Only*

7.9.5.1 Slowly tilt the receiver in the vertical plane (for example, adjust the appropriate alignment bolts or mounting mechanism) until an error of $\pm 2\%$ opacity is first indicated on the data recorder. Verify that the alignment indicator shows misalignment.

7.9.5.2 Illustrate and record the alignment indicator and the degree of misalignment shown.

7.9.5.3 Return the system to its aligned condition and again draw the alignment indicator.

7.9.5.4 Repeat the entire procedure by tilting the receiver in the opposite direction.

7.9.5.5 Repeat the rotational misalignment check of the receiver in the horizontal plane (both to the left and right) and again illustrate and record the visual depiction of the alignment for each step of the procedure.

7.9.6 *Case 3: Single and Double Pass Opacity Monitors:*

7.9.6.1 Achieve lateral misalignment of the transceiver or transmitter relative to the reflector or receiver by slowly moving either assembly linearly to the left until a positive or negative error of $\pm 2\%$ opacity is first indicated on the data recorder. Verify that the alignment indicator shows lateral misalignment of the transceiver or transmitter relative to reflector or receiver.

7.9.6.2 Illustrate and record the alignment indicator and the degree of misalignment shown.

7.9.6.3 Return the system to its aligned condition and again draw the alignment indicator.

7.9.6.4 Repeat the entire procedure by moving the same component to the right.

7.9.6.5 Repeat the test in the vertical plane (both above and below the aligned position) and again illustrate and record the visual depiction of the alignment for each step of the procedure.

7.9.7 *Assessment*—Determine conformance with the specification in 7.9.1.

NOTE 364—The performance of the alignment indicator is acceptable if: (1) for each case of rotational or translational misalignment, misalignment is clearly shown when an error of $\pm 2\%$ single-pass opacity first occurs in each direction, and (2) proper alignment status is consistently indicated when the opacity monitor is optically aligned. A clear indication of misalignment is one that is objectively apparent relative to reference marks or conditions; an alignment device that requires a subjective judgement of the degree of misalignment is not acceptable.

7.9.8 *Automatic Beam Steering:*

7.9.8.1 If the design includes automatic beam steering, investigate each case of rotational and translational misalignment. Vary the alignment over the manufacturer's specified range of angular tolerance for which the alignment is maintained and for which the opacity is maintained within $\pm 2\%$ single pass opacity.

7.9.8.2 During each misalignment test, record the angular misalignment where the alarm is activated.

7.9.8.3 Determine conformance with the specification in 7.9.2.

NOTE 375—Acceptable performance is indicated if (1) the alarm is activated or misalignment is clearly shown at, or before, the angular tolerance specified by the manufacturer is reached, and (2) for translational misalignment, an alarm is activated or misalignment is clearly shown at, or before, an error of $\pm 2\%$ single-pass opacity first occurs in each direction.

7.10 *Spectral Response Performance Check:*

NOTE 386—This performance check provides a simple method to ensure that the spectral response of each instrument satisfies the spectral response design specifications of 6.2. The performance check uses a ~~photopic~~ transmission filter placed in the measurement beam and comparison with a range of expected responses determined from Monitor-Specific Performance Check Limits (6.2.7).

7.10.1 *Specification*—The transmissometer response to the ~~photopic~~ transmission filter used to establish performance check limits, after correction of the response to account for the applicable pathlength correction factor, must be within $\pm 2\%$ opacity of the range defined by the maximum and minimum responses (determined in 6.2.7 in units of percent opacity).

7.10.2 *Spectral Response Performance Check Procedure:*

7.10.2.1 Insert the ~~photopic~~ transmission filter used to establish the performance check limits into the opacity monitor measurement beam after the calibration error test has been completed. Record the opacity monitor response to the ~~photopic~~ transmission filter in units of percent opacity.

7.10.2.2 Correct the opacity monitor response to the equivalent value corresponding to a pathlength correction factor of 1.

7.10.2.3 Compare the corrected response to the acceptable limits and determine conformance with the specification in 7.10.1.

7.10.2.4 If an unacceptable result is obtained, do not assume that the spectral response design requirements are met. Investigate the causes for an unacceptable result. Unless a clear explanation of the problem is apparent, repeat Spectral Response Design

Specifications Verification Procedure (6.2.3) and recalibrate the ~~photopic~~ transmission filter.

7.11 *Calibration Device Value and Repeatability:*

NOTE 397—The purpose of this specification is to verify that the upscale calibration device response is repeatable and provides results consistent with the use of external filters. This specification may also be applied to additional internal calibration check devices (values), if provided in the instrument.

7.11.1 *Specification*—The 95 % confidence coefficient for repeated measurements of the upscale calibration device must be less than 1.5 % opacity. The upscale calibration device must be assigned a value relative to the calibration error test results for the specific opacity monitor.

7.11.2 *Calibration Device Repeatability Test Procedure*—Perform this procedure immediately after successfully completing the calibration error test for the opacity monitor. Do not make any adjustments to the opacity monitor until after this procedure has been completed. Make ~~seven~~ five non-consecutive measurements of each internal device and record the opacity monitor responses.

7.11.2.1 Calculate the 95 % confidence coefficient using the same procedures as that used in the calibration error test. (See 7.8.2.4).

7.11.2.2 Determine conformance to the specification in 7.11.1.

7.11.2.3 ~~Assign values to the upscale calibration device(s) relative average value(s) to the calibration error test results. Construct a calibration curve by linear regression analysis through zero of the results of the calibration error test (x-axis are correct values and y-axis are the corresponding opacity monitor responses). Using the mean of the five measurement responses for each upscale calibration device as the y-axis value, determine in corresponding x-axis value from the calibration curve. Assign this value to the internal upscale calibration device. device(s).~~

8. Quality Assurance Guidelines for Opacity monitor Manufacturers

8.1 *General*—The products shall be manufactured under a quality program that ensures that like products, subsequently made, have the same reliability and quality as those originally examined to determine compliance with this design specification. To establish and maintain such a program, the manufacturer shall be guided by industry practice, its quality controls, and by this set of guidelines. These guidelines are supported by various standards and by industry practice.

8.1.1 *Applicable Documents*—This document is an adaptation of and the referred to the following standards for additional guidance:

ISO/DIS 9004 Quality Management and Quality System Elements-Guidelines

ANSI/NCSL Z 540-1-1994, Calibration Laboratories and Measuring Equipment - General Requirements

8.1.2 *General Vocabulary*—Terms used in this document are defined by:

ISO 842, Quality Vocabulary

8.2 *Quality System:*

8.2.1 *Management Responsibility:*

8.2.1.1 *Quality Policy*— The management of a company shall develop and promulgate a corporate quality policy. Management shall ensure that the corporate policy is understood, implemented and maintained.

8.2.1.2 *Quality Objectives*—Based on this policy, key quality objectives shall be defined, such as fitness for use, performance, reliability, safety, and so forth.

8.2.1.3 *Quality Management Systems* —A documented system shall be developed, established and implemented for the product as a means by which stated quality policies and objectives can be realized. The quality system should ensure that: (1) it is understood and effective; (2) products actually do satisfy customer expectations; (3) emphasis is placed on problem prevention rather than dependence on detection after occurrence; (4) causes, not only symptoms, of a problem are found, and that corrections are comprehensive, touching any activity that has a bearing on quality; and (5) feedback is generated that can be used at the product or process design stage for correcting problems and improving product. Management shall provide the resources essential to the implementation of quality policies and objectives.

8.2.2 *Quality System Documentation and Records*—The elements requirements and provisions adopted for the quality management system shall be documented in a systematic and orderly manner.

8.2.2.1 Documentation shall be legible, clean, readily, identifiable and maintained in an orderly manner.

8.2.2.2 The quality management system shall establish and require the means for identification, collection, filing, storage, maintenance, retrieval and disposition of pertinent quality documentation and records. Methods shall be established for making changes, modifications, revisions or additions to the contents of applicable documentation in a controlled manner.

8.3 *Corrective Action Program:*

8.3.1 *Introduction*— There shall be a comprehensive defect analysis/corrective action program for reporting and following-up on product and program deficiencies.

8.3.2 *Assignment of Responsibility :*

8.3.2.1 The responsibility and authority for instituting corrective action shall be defined as part of the quality system.

8.3.2.2 The coordination, recording and monitoring of corrective action shall be assigned to a specific person or group within the organization. (The analysis and execution of any corrective action may involve a variety of people from such areas as sales, design, production engineering, production and/or quality control.)

8.3.3 *Deficiencies:*

8.3.3.1 Deficiencies shall be evaluated in terms of their potential impact on product quality, reliability, safety, performance and customer satisfaction.

8.3.3.2 The relationship between cause and effect should be determined. The root cause should be determined before planning and implementing corrective measures. Careful analysis shall be given to the product and all related processes, operations, records, and so forth.

8.3.3.3 Controls of processes and procedures shall be implemented to prevent recurrence of the problem. When the corrective measures are implemented, their effect shall be monitored in order to ensure desired goals are met.

8.3.3.4 Permanent changes resulting from corrective action shall be incorporated into the work instructions, manufacturing

processes, product specifications and/or the quality manual.

8.4 *Quality System Certification* —Companies with ISO 9001/9002 certification, companies meeting the requirements of ANSI/ASQC Q90 (Q91 or Q92), companies meeting the requirements of nationally recognized test laboratories (NRTLs) where the manufactured product bears the mark (or marks) of the NRTL(s), or companies with an equivalent independently and periodically verified quality system, and which adopt this specification as part of their product definition shall be deemed to meet all of the above quality assurance guidelines. Companies meeting these conditions shall attach the applicable certification to the manufacturer's certification of conformance report as proof of such designation.

9. Report

- 9.1 Summarize the design and performance (see Table 1, Table 2 and Table 3) data in the report. See Fig XI.1 for an example.
- 9.2 Include all descriptive information, such as:
 - 9.2.1 Manufacturer or supplier information,
 - 9.2.2 Opacity monitor information,
 - 9.2.3 User information, and
 - 9.2.4 Installation information.

10. Keywords

- 10.1 continuous opacity monitor; design specification; performance specification; transmissometer

APPENDIX

(Nonmandatory Information)

X1. DATA SUMMARY FORM

X1.1 Fig. X1.1 is an example data form to summarize data to certify conformance with design and performance specifications. This example may be used as a starting point for the development of an appropriate monitor-specific report. This example may not include all of the relevant or necessary information for particular opacity monitors. Those organizations involved with the manufacturer's certification of conformance with the requirements of this Standard Practice are encouraged to examine carefully all of the requirements as they apply to the specific models tested and expand or modify this example to include all information necessary to support certification of the subject opacity monitors. ~~is an example data form~~

SUMMARY OF CHANGES

Note: Table 1 will be editorially revised to summarize data include cross references to the applicable sections of the standard practice for each of the listed specifications. This will assist users in locating the applicable sections.

Committee D22.03 has identified the location of selected changes to this standard since the last issue (1998) that may impact use of this standard.

D 6216 -03:

- (1) The standard has been revised consistent with August 10, 2000 promulgated revisions to EPA Performance Specification 1 (40CFR60, Appendix B) which adopt this ASTM standard by reference.
- (2) Numerous editorial revisions have been included to clarify and correct the standard and eliminate confusion wherever possible.
- (3) Test to determine conformance with manufacturer's design specifications performed on an annual or monthly basis including angle of projection, angle of view, insensitivity to supply voltage variations, thermal stability, insensitivity to ambient light have been modified to use a consistent 3 meter flange-to-flange set up distance (or equivalent).
- (4) Procedures for conducting the insensitivity to line voltage variation tests and the procedures for the calibration device repeatability test have been simplified through minor changes.
- (5) The procedures for the spectral response performance check have been significantly improved based on changes to the specifications for the transmission filter used for the tests. The revised procedure will better detect changes in spectral response for all monitor types and uses more readily available materials.
- (6) The insensitivity to ambient light test has been significantly modified and now based on use of artificial lighting under laboratory conditions rather than testing out of doors with natural lighting. The revised test procedure is a more rigorous test for opacity monitors, is a more robust evaluation procedure, and it also facilitates independent audits or observations of these tests.

This document is provided by (company name), an (original manufacturer, supplier, re-manufacturer, or service facility), of/for opacity monitoring systems that are intended to comply with standards of performance established by the US EPA 40CFR60, Appendix B, Performance Specification 1, Performance Specifications for Opacity Monitors. This EPA specification references the above ASTM Standard Practice, which may be used by the manufacturer or supplier to demonstrate that the designated opacity monitor meets those performance requirements that can be tested and verified by the supplier prior to field installation. Data in this summary document (Part I) have been generated in compliance with the procedures and specifications shown in the ASTM Standard Practice, D 6216. These data confirm that the designated opacity monitor meets or exceeds the requirements of this Standard Practice.

I. MANUFACTURER/SUPPLIER INFORMATION

Company name _____
 Location _____

II. OPACITY MONITOR INFORMATION

Model _____
 Transceiver type _____
 Transceiver serial no. _____
 Reflector type _____
 Reflector serial no. _____
 Control unit serial no. _____
 Software version(s) no. _____

III. USER INFORMATION

Company _____
 Plant _____
 Process/boiler _____
 Location _____

IV. INSTALLATION INFORMATION

Monitoring pathlength (depth of effluent) _____
 Installation pathlength (flange to flange) _____
 Emission outlet pathlength (stack exit) _____
 PLCF or (OPLR) _____
 Facility opacity standard, % opacity _____
 Opacity full scale, % opacity _____

FIG. X1.1 Data Summary Form

The changes to this standard are based on significant experience in manufacture's testing and certification of opacity monitors that has been gained since D 6216 - 98 was published and EPA revised its regulations to require its use in numerous regulatory applications. An opacity monitor that can be demonstrated to meet the revised D6216 would certainly meet the requirements of D 6216 - 98.

PART I—DESIGN AND PERFORMANCE SPECIFICATIONS-TESTED AT MANUFACTURER'S FACILITY

Conformance with design specifications is demonstrated by testing two separate opacity monitors, each of which is representative of standard production. One opacity monitor is selected and tested annually and the other is selected from either a production lot of instruments not to exceed 20 in size, or from monthly production, and tested in accordance with procedures described in the D 6216. The tests associated with each of the above selected analyzers is required to be repeated anytime there is a critical component change that is substantial, hardware or software change, or manufacturing process change that could affect performance with respect to said design specifications. The test data derived from each of the above two described analyzers is summarized below.

1. Design Specifications Verified Through Tests Prescribed For An Annually, or More Often, Selected Opacity Monitor

The opacity monitor that tested to demonstrate the following design parameters was selected on the basis of an annual selection _____, or following a major change in the design or construction of the monitor _____.

OPACITY MONITOR INFORMATION

Model _____
 Transceiver type _____
 Transceiver serial no. _____
 Reflector type _____
 Reflector serial no. _____
 Control unit serial no. _____
 Software version no. _____

TESTS PERFORMED BY: _____

DATE: _____

TEST DATA REVIEWED AND CERTIFIED BY: _____

DATE: _____

1.1 Spectral Response

Data listed below were obtained by calculation _____, or by actual measurement using a monochrometer _____. A description of either the calculations or the measurement test setup are included in Attachment A.

Parameter	Specification	Actual Test Result
Peak response	Between 500-600 nm	
Mean response	Between 500-600 nm	
Max response beyond 700 nm	Less than 10% of peak	
Max response less than 400 nm	Less than 10% of peak	

FIG. X1.1 Data Summary Form (continued)

1.2 Thermal Stability

Parameter	Specification	Actual Test Result
Tested range, min temp	Mfgr specified, °C (°F)	
Tested range, max temp	Mfgr specified, °C (°F)	
Nominal measurement value	10-20% opacity	
Measurement drift, max deviation from nominal measurement value	≤ 2% opacity/22 °C (40°F)	
Zero drift from nominal without compensation	≤ 2% opacity/22°C (40°F)	
Zero drift from nominal with compensation	≤ 2% opacity/22°C (40°F)	
Upscale drift from nominal without compensation	≤ 2% opacity/22°C (40°F)	
Upscale drift from nominal with compensation	≤ 2% opacity/22°C (40°F)	

1.3 Insensitivity to Ambient Light

Parameter	Specification	Actual Test Result
Max solar intensity	900 W/m ²	
Nominal measurement value	10-20% opacity	
Measurement drift, max deviation from nominal measurement value	≤ 2% opacity	
Drift was corrected for thermal effects, yes or no	Mfgr specified	
Zero drift from nominal without compensation	≤ 2% opacity	
Zero drift from nominal with compensation	≤ 2% opacity	
Upscale drift from nominal without compensation	≤ 2% opacity	
Upscale drift from nominal with compensation	≤ 2% opacity	

1.4 Calibration Device Availability

Parameter	Specification	Availability/Value
External zero device	Optional	
Ext zero device repeatability	≤ 1% opacity	
External filter access	To be available	

FIG. X1.1 Data Summary Form (continued)

1.5 *Zero/upscale calibration check apparatus*

Parameter	Specification	Test Result
Indicated response to simulated zero calibration device	0 ± 0.5% opacity	
Simulated Zero Check	Simulated condition during which the energy reaching the detector is between 90 and 190% of the energy reaching the detector under actual clear path conditions *	
Response to upscale calibration device without electronic hardware or software modification	+10% opacity to highest calibration error attenuator value	
Do automatic zero and upscale calibration check devices check all active optics and electronics?	Required	
Is automatic correction provided for zero drift?	Mfgr to specify (Y/N)	
	If yes, specify frequency	
Is automatic correction provided for dust accumulation on exposed optics?	Mfgr to specify (Y/N)	
	If yes, specify frequency	
Is automatic correction provided for upscale calibration drift?	Mfgr to specify (Y/N)	
	If yes, specify frequency	

Note: * Negative opacity values of this magnitude can be calculated from the detector or preamplifier output by measuring the equivalent optical energy detected in the clear path condition and that produced by the zero calibration check device.

1.6 *PLCF (OPLR) Security Precautions*

Condition	Specification	As Supplied (Y/N)
Original certified value is fixed and not adjustable by user without assistance from manufacturer	One or more of listed conditions to be provided	
Value is output with zero and upscale drift values during each calibration cycle	One or more of listed conditions to be provided	
Alarm (Flag) is activated when changed from original certified or permanently recorded value	One or more of listed conditions to be provided	

FIG. X1.1 Data Summary Form (continued)

1.7 Faults and Alarm (Mfgr to specify)

Fault Conditions (Note 1&3)	Specified Indication	Actual Indication
Conditions tested	Audible or visual, and electrical	Tested output
	Same	
	Same	
	Same	
Alarm Conditions (Note 2&3)	Specified Indication	Actual Indication
Conditions tested	Audible or visual, and electrical	Tested output
	Same	
	Same	
	Same	
	Same	
	Same	

Note 1) Fault conditions are those conditions which, when they occur, are deemed by the manufacturer to result in performance which is not in compliance with this performance specification.

Note 2) Alarm conditions are those conditions for which the manufacturer recommends review and/or corrective action by trained service personnel as appropriate to prevent further deterioration of instrument performance which could result in performance not in compliance with this specification.

Note 3) Manufacturer may use other nomenclature to designate either general or specific alarms and/or faults, as long as they are appropriately defined in the operators manual.

FIG. X1.1 Data Summary Form (continued)

1.8 Miscellaneous

Parameter	Specification	Test Result
Resolution of visual measurement indication, if provided	≤ 0.5% opacity	
Resolution of analog output measurement indication	≤ 0.5% opacity	
Resolution of serial digital output, if provided	≤ 0.5% opacity	
Bipolar range of visual measurement indication	+50% opacity or more to -4% opacity or less	
Capability of analog output measurement indication to indicate negative values to at least -4% opacity	Required	
Are means available to monitor daily zero and upscale calibration drift before correction?	Optional	
Is upscale calibration drift corrected for zero drift in above method?	Optional	
Are means available to monitor dust accumulation on exposed optical surfaces?	Optional	
What surfaces are monitored for dust accumulation?	Mfgr to specify, if applicable	
Is an alarm provided for excessive dust accumulation?	Mfgr to specify, if automatic correction is provided	
What level of dust accumulation triggers the above alarm?	Mfgr to specify, if applicable	
Is dust level measured separately from the accumulative zero drift?	Mfgr to specify	
Are all dust (if provided), zero, and upscale calibration values corrected to stack exit conditions?	Required	
What is the normal update interval for opacity measurements?	10 sec max	
Do longer term opacity averages include at least 6 approximately equally distributed individual measurement values per minute?	Required	

FIG. X1.1 Data Summary Form (continued)

2. Design Specifications Verified Through Tests Prescribed for an Opacity Monitor Selected on a Monthly Basis, or From Each Production Lot

The opacity monitor that was selected and tested to demonstrate the following design parameters was selected on the basis of a monthly selection _____, a manufacturing lot not to exceed 20 in size _____, or following a major change in the design or construction of the monitor _____.

OPACITY MONITOR INFORMATION

Model _____
 Transceiver type _____
 Transceiver serial no. _____
 Reflector type _____
 Reflector serial no. _____
 Control unit serial no. _____
 Software version no. _____

TESTS PERFORMED BY:

_____ DATE: _____

TEST DATA REVIEWED AND CERTIFIED BY:

_____ DATE: _____

2.1 Angle of View

Transmissometer is exempt from angle of view specification because the angle of projection has been demonstrated to be less than _____ degrees.

Portion of opacity monitor included in the test: _____

Portion of opacity monitor excluded in the test: _____

Light source used in the test: directional _____, or non-directional _____

Were detector/measurement electronics modified to measure response to designated light source: (Y/N) _____. If so, describe modifications in attachment B.

Parameter	Specification	Actual Test Result
Angle of view, horizontal	≤ 4° for all radiation providing a response of ≥ 2.5% of peak response	
Angle of view, vertical	≤ 4° for all radiation providing a response of ≥ 2.5% of peak response	

FIG. X1.1 Data Summary Form (continued)

2.2 Angle of Projection

Transmissometer is exempt from angle of projection specification because the angle of projection has been demonstrated to be less than _____ degrees.

Option 1 Procedure

Portion of opacity monitor included in the test: _____

Portion of opacity monitor excluded in the test: _____

Photodetector used in test: _____

_____ If tests were conducted with dc coupled measurement circuit, was ambient light level less than 0.5% of peak light intensity? (Y/N) _____

_____ If tests were conducted with ac coupled measurement circuit, was it demonstrated that ambient light levels did not saturate the detector? (Y/N) _____; and was it demonstrated that turning on/off ambient lights did not affect measurements? (Y/N) _____.

Parameter	Specification	Actual Test Result
Angle of projection, horizontal	≤ 4° for all radiation providing a response of ≥ 2.5% of peak response	
Angle of projection, vertical	≤ 4° for all radiation providing a response of ≥ 2.5% of peak response	

Option 2 Procedure (For transmissometer designs that have previously met the AOP specification using Option 1 procedure during the preceding 12 months)

Distance from transceiver/transmitter to target _____

Beam dimension (diameter) in the vertical direction _____

Beam dimension (diameter) in the horizontal direction _____

Option 2 Result: (total subtended angle): _____ degrees.

Option 1 Result (angle of projection): _____ degrees

Difference (Option 1 result minus Option 2 result) _____ degrees. If the results do not agree within 0.3 degrees, repeat the test using Option 1.

FIG. X1.1 Data Summary Form (continued)

2.3 Insensitivity to supply voltage variations

Manufacturers specified nominal voltage: _____

Manufacturers specified operating voltage range, if specified: _____

Parameter	Specification	Actual Test Value
Min test voltage	-10% from nom, or mfgs min specified operating voltage, whichever is lesser	
Max test voltage	+10% from nom, or mfgs max specified operating voltage, whichever is greater	
Nominal measurement value	10-20% opacity	
Measurement drift, max deviation from nominal measurement value from nominal to max ac voltage	± 1% opacity	
Measurement drift, max deviation from nominal measurement value from nominal to min ac voltage	± 1% opacity	
Zero drift from nominal to min ac voltage without compensation	± 1% opacity	
Zero drift from nominal to min ac voltage with compensation	± 1% opacity	
Upscale calibration drift from nominal to min ac voltage without compensation	± 1% opacity	
Upscale calibration drift from nominal to min ac voltage with compensation	± 1% opacity	
Zero drift from nominal to max ac voltage without compensation	± 1% opacity	
Zero drift from nominal to max ac voltage with compensation	± 1% opacity	
Upscale calibration drift from nominal to max ac voltage without compensation	± 1% opacity	
Upscale calibration drift from nominal to max ac voltage with compensation	± 1% opacity	

FIG. X1.1 Data Summary Form (continued)

3. Performance Specifications Verified by Tests Prescribed for Each Specific Opacity Monitor.

The following tests were performed individually on the specific instrument described in the beginning of this test report. Further, the following signatures attest to the fact that the design and performance specifications tested on previous opacity monitors, as described in Sections 1 and 2, are representative of the design and performance of this specific monitor.

TESTS PERFORMED BY: _____

DATE: _____

TEST DATA REVIEWED AND CERTIFIED BY: _____

DATE: _____

3.1 Calibration error

Filter	Specify Group, Group I or II	Actual Filter Value	Specified Cal Error	Actual Cal Error
Low	Group		3%	
Mid	Group		3%	
High	Group		3%	

Note: Group I filters are 5-10, 10-20, 20-40 percent opacity (low, mid, high)
 Group II filters are 10-20, 20-30, 30-60 percent opacity (low, mid, high)

3.2 Response Time Test

Test Number	Upscale Response (sec)	Downscale Response (sec)
1		
2		
3		
4		
5		
Mean		

3.3 Misalignment indication

This opacity monitor uses (a) manual alignment and visual alignment sighting device (Y/N) _____, or b) automatic beam steering (Y/N) _____.

FIG. X1.1 Data Summary Form (continued)

3.3.1 For manually aligned opacity monitors with visual alignment sighting indicator:

A. Rotational misalignment

Parameter	Specification	Test Result
Nominal measurement value	0-10% opacity	
Indication of centered alignment	Acceptable? (Y/N)	
Clear indication of misalignment for rotational misalignment for transceiver/transmitter in upward vertical direction which causes 2% opacity change	Acceptable? (Y/N)	
Clear indication of misalignment for rotational misalignment for transceiver/transmitter in downward vertical direction which causes 2% opacity change	Acceptable? (Y/N)	
Clear indication of misalignment for rotational misalignment for transceiver/transmitter in horizontal right direction which causes 2% opacity change	Acceptable? (Y/N)	
Clear indication of misalignment for rotational misalignment for transceiver/transmitter in horizontal left direction which causes 2% opacity change	Acceptable? (Y/N)	

B. Lateral misalignment, same test conditions

Parameter	Specification	Test Result
Clear indication of misalignment for lateral movement to the left which causes 2% opacity change	Acceptable? (Y/N)	
Clear indication of misalignment for lateral movement to the right which causes 2% opacity change	Acceptable? (Y/N)	
Clear indication of misalignment for lateral movement in upward direction which causes 2% opacity change	Acceptable? (Y/N)	
Clear indication of misalignment for lateral movement in downward direction which causes 2% opacity change	Acceptable? (Y/N)	

FIG. X1.1 Data Summary Form (continued)

3.3.2 For opacity monitors with automatic beam steering.

Parameter	Specification	Test Result
Nominal measurement value	0-10% opacity	
Indication of centered alignment	Acceptable? (Y/N)	
Degree of rotational misalignment for transceiver/transmitter in upward vertical direction which triggers alarm	Mfgr to specify	
Degree of rotational misalignment for transceiver/transmitter in downward vertical direction which triggers alarm	Mfgr to specify	
Degree of rotational misalignment for transceiver/transmitter in horizontal right direction which triggers alarm	Mfgr to specify	
Degree of rotational misalignment for transceiver/transmitter in horizontal left direction which triggers alarm	Mfgr to specify	
Lateral movement of transceiver/transmitter in upward vertical direction which causes an indication of misalignment	Mfgr to specify movement	
What is maximum deviation of opacity from nom when opacity monitor is misaligned as above from centered to value noted?	≤ 2% opacity	
Lateral movement of transceiver/transmitter in downward vertical direction which causes an indication of misalignment	Mfgr to specify movement	
What is maximum deviation of opacity from nom when opacity monitor is misaligned as above from centered to value noted?	≤ 2% opacity	
Lateral movement of transceiver/transmitter in horizontal right direction which causes an indication of misalignment	Mfgr to specify movement	
What is maximum deviation of opacity from nom when opacity monitor is misaligned as above from centered to value noted?	≤ 2% opacity	
Lateral movement of transceiver/transmitter in horizontal left direction which causes an indication of misalignment	Mfgr to specify movement	
What is maximum deviation of opacity from nom when opacity monitor is misaligned as above from centered to value noted?	≤ 2% opacity	

FIG. X1.1 Data Summary Form (continued)

3.4 Spectral Response Repeatability

Date of spectral response transmission filter calibration _____

Monotonically decreasing transmission filter between 500 and 600 nm calibration date: _____

Wavelength (nm)	Specification (Transmittance)	Actual (Transmittance)
500	> 80%	
510		
520		
530		
540		
550	50% transmission point (550-575 nm)	
560	50% transmission point (550-575 nm)	
570	50% transmission point (550-575 nm)	
580		
590		
600	< 20%	
625	< 5% above 625	

Calculated nominal response of analyzer to transmission filter _____, % opacity

Calculated allowable variation of the response to transmission filter:

OP, high _____, OP, low _____

Above opacity values converted to stack exit values according to the specific PLCF (OPLR) established for this installation: PLCF (OPLR) _____

OPc, nom _____, OPc, high _____, OPc, low _____

Actual measured response of the instrument to transmission filter _____ % opacity

Is measured response within previously calculated range (Y/N) _____

3.5 Upscale Calibration Device Repeatability

Mean value of five measurements: _____

95% Confidence Coefficient: _____ (%opacity) Specification is <1.5% opacity

36 Intrinsic opacity monitor settings/adjustments

List all configurable parameters to obtain the performance described in this report. These parameters typically include calibration check intervals, calibration check correction, procedure settings relating to flange-to-flange separation distance, range, averaging time, alarms, etc.

FIG. X1.1 Data Summary Form (continued)

This document is provided by (company name), an (original manufacturer, supplier, re-manufacturer, or service facility), of/for opacity monitoring systems that are intended to comply with standards of performance established by the US EPA 40CFR60, Appendix B, Performance Specification 1, Performance Specifications for Opacity Monitors. This EPA specification references the above ASTM Standard Practice, which may be used by the manufacturer or supplier to demonstrate that the designated opacity monitor meets those performance requirements that can be tested and verified by the supplier prior to field installation. Data in this summary document (Part I) have been generated in compliance with the procedures and specifications shown in the ASTM Standard Practice, D 6216. These data confirm that the designated opacity monitor meets or exceeds the requirements of this Standard Practice.

I. MANUFACTURER/SUPPLIER INFORMATION

Company name _____
 Location _____

II. OPACITY MONITOR INFORMATION

Model _____
 Transceiver type _____
 Transceiver serial no. _____
 Reflector type _____
 Reflector serial no. _____
 Control unit serial no. _____
 Software version(s) no. _____

III. USER INFORMATION

Company _____
 Plant _____
 Process/boiler _____
 Location _____

IV. INSTALLATION INFORMATION

Monitoring pathlength (depth of effluent) _____
 Installation pathlength (flange to flange) _____
 Emission outlet pathlength (stack exit) _____
 PLCF or (OPLR) _____
 Facility opacity standard, % opacity _____
 Opacity full scale, % opacity _____

FIG. X1.1 Data Summary Form

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